

Use of Instrumentation in a Radiological Environment

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For the ASP2012





Headlines:

Instrumentation
Identification
Requirements
Installation techniques

Radiological Environment

LHC measurements and Process

- “An instrument is a device that measures and/or regulates physical quantity/process variables such as flow, temperature, level, or pressure.
- Requirements:
 - Operating Range, excitation, Output signal, Size, Offset,
 - Stability, interchangeability, Ease of Use, Cost
 - Resolution : what is the smallest detected change
 - Precision (reproducibility or stability) : how close to the measurement value?
 - Accuracy: Closest between the results of a measurement and the true value.
 - Effect on its environment
 - Environmental compatibility:
 - Robustness
 - Response time
 - Magnetic field effects
 - Radiation resistance
 - Electromagnetic noise effect



- Don't use more accuracy & precision than required
- Use commercially produced sensors whenever possible
- Mount sensors to provide an easy access for maintenance
- Install redundant sensors for critical devices in remote location
- Be sure to consider how to recalibrate sensors
- Once R&D is done, minimize number of sensors in series production

- The probable resolution, precision, or accuracy of a measurement can be evaluated using uncertainty analysis.
- Same unit than the quantity measured.

$$u_c = \sqrt{u_1^2 + u_2^2 + u_3^2 + u_4^2 + \dots + u_n^2}$$

- Source of measurement uncertainty
 - 1) Sensor excitation
 - 2) Sensor self-heating (in cryogenic environment)
 - 3) Thermo-electric voltage and zero drift
 - 4) Thermal noise
 - 5) Electromagnetic noise
 - 6) Sensor calibration
 - 7) Interpolation and fitting of the calibration data

- Critical to the proper use of temperature sensors in vacuum spaces
 - You want to measure the temperature of the sensor not that due to heat leak down the wire
- Use 4-wire measurement
- Use low conductivity wires with small cross sections

Table 4-3 Wire heat-sinking lengths required to thermally anchor to a heat sink at temperature T to bring the temperature of the wire to within 1 mK of T

| Material | T_1 [K] | T_s [K] | Heat-sinking length, L_2 (mm) for wire sizes | | | |
|-----------------|--------------|--------------|--|-----------------------------------|-----------------------------------|-----------------------------------|
| | | | 0.21 mm ² (24 AWG) | 0.032 mm ² (32 AWG) | 0.013 mm ² (36 AWG) | 0.005 mm ² (40 AWG) |
| Copper | 300 | 80 | 160 | 57 | 33 | 19 |
| | 300 | 4 | 688 | 233 | 138 | 80 |
| Phosphor-Bronze | 300 | 80 | 32 | 11 | 6 | 4 |
| | 300 | 4 | 38 | 13 | 7 | 4 |
| Manganin | 300 | 80 | 21 | 4 | 4 | 2 |
| | 300 | 4 | 20 | 7 | 4 | 2 |
| 304 ss | 300 | 80 | 17 | 6 | 3 | 2 |
| | 300 | 4 | 14 | 5 | 3 | 2 |

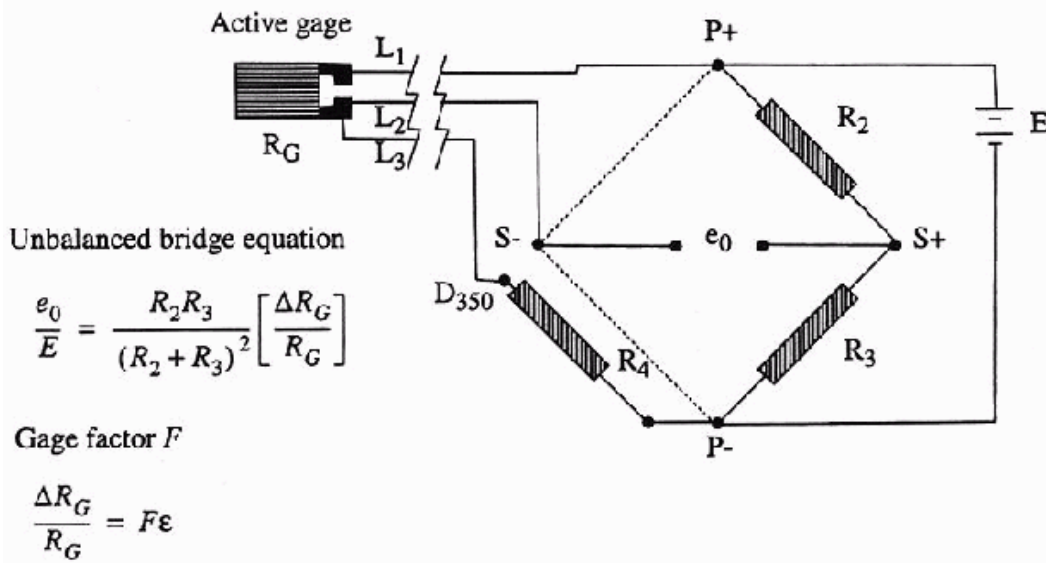
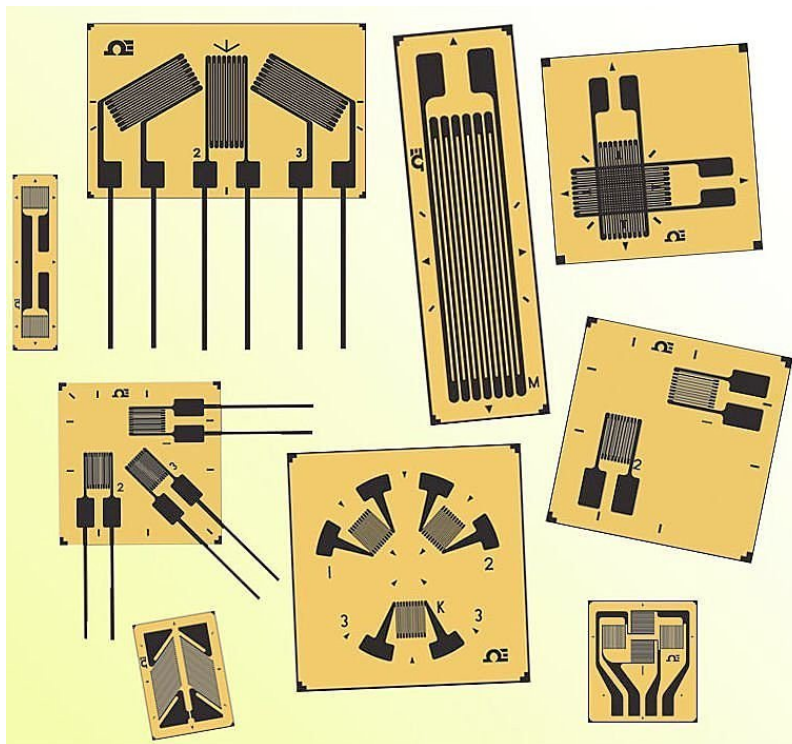
Note: Values are calculated assuming wires are in a vacuum environment, and the thermal conductivity of the adhesive is given by the fit to the thermal conductivity of GE 7031 varnish.

*Ref: "Cryogenic Instrumentation" – D.S. Holmes and S. Courts
Handbook of Cryogenic Engineering*

Strain Measurement

- Bond resistance strain gages, with relative resistance change according to the formula:

$$\frac{\Delta R}{R} = F_s \left(\frac{\Delta L}{L} \right)$$

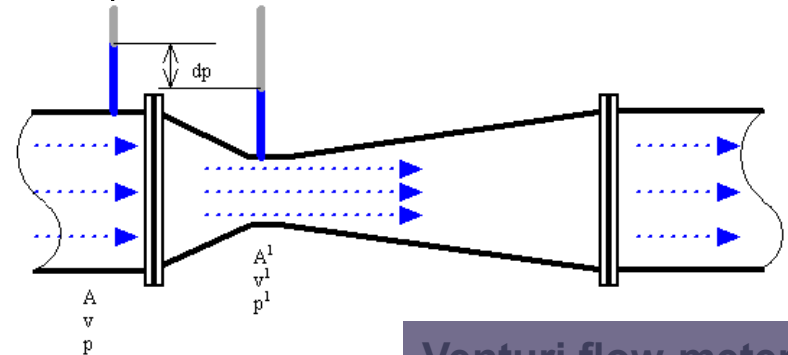


- Superconducting level gauges for LHe service
- Differential pressure techniques
- Capacitive technique
- Self heating of sensors
- Floats (e.g. LN₂)



- Measure a mass flow or a volumetric flow
- Differential pressure
(simple construction, no moving parts, external instrumentation and low maintenance) *e.g. Orifice, Venturi, V-Cone, Pitot tube*

$$\rho \frac{v^2}{2} + p + \rho g z = \text{constant}$$



Venturi flow-meter

- Variable Area flow-meters
(simplest and cheapest types of meter)

- Thermal Mass

$$q = \Delta T \left[k + 2(k C_v \rho \pi d \tilde{v})^{1/2} \right]$$

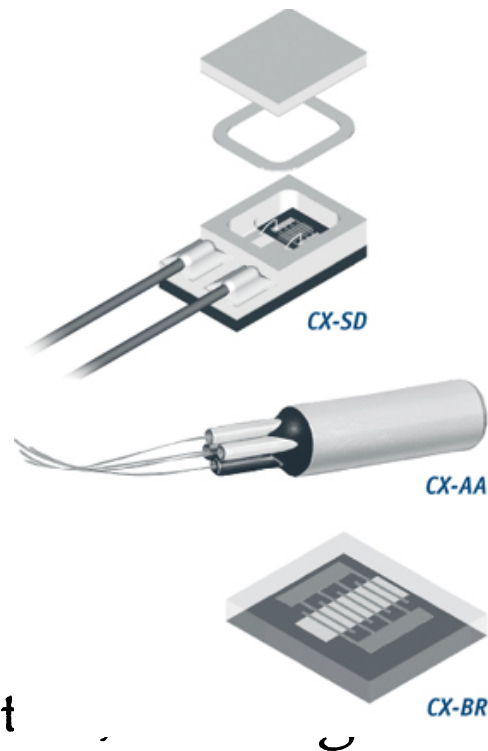
- Others: Turbine, Vortex, Target

| | Ultimate accuracy | range-ability | pressure loss and piping requirements | recommended applications | cost |
|-----------------------|-------------------|---------------|---------------------------------------|--------------------------|--------|
| orifice | 1 - 2 % | medium | high / 10-30 D | clean gas | low |
| venturi | 1 % | medium | low / 5-10 D | dirty gas | high |
| V-cone | 0.5-1 % | medium | medium / 3-5 D | short pipes | medium |
| pitot tube | 3% | medium | low / 20-30 D | velocity meas. | low |
| variable area | 1-10 % | medium | medium / none | flow indicator | low |
| positive displacement | 1 % | good | high / none | consumption measurement | high |
| thermal mass | 1 % | good | low / none | mass flow measurement | high |
| turbine | 0.3 % | good | high / 10-20 D | accuracy | high |
| vortex | 0.75 % | good | low / 15-25 D | no maintenance | medium |
| target | 0.5-2 % | low | high / 10-20 D | no maintenance | low |

Handbook of Applied Superconductivity, Volume 2

Print ISBN: 978-0-7503-0377-4

- **Metallic resistors**
 - Platinum RTD
 - Rodium-iron RTD
- **Semiconductor resistors**
 - Carbon-glass RTDs
 - Carbon-Glass resistors
 - Cernox™
 - Silicon Diodes
 - Germanium RTD
 - Ruthenium Oxide
- **Semiconductor Diodes (fast response t**
- **Capacitor**
- **Thermocouples**

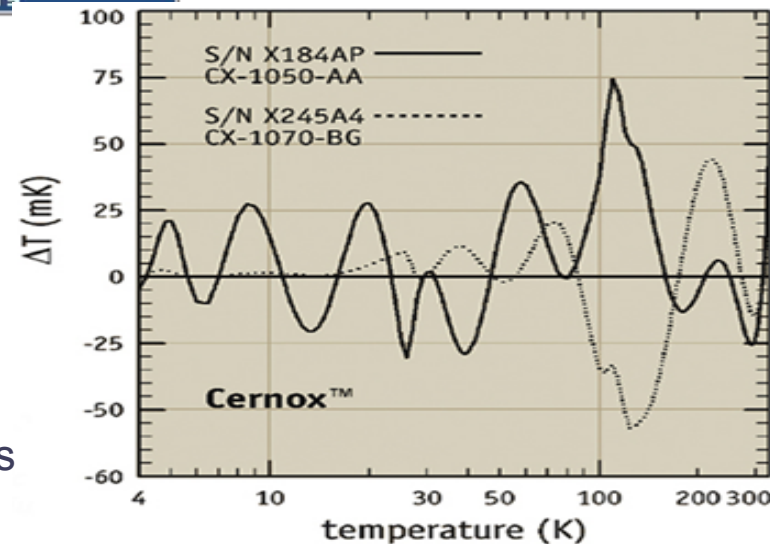


| Temperature Range of Typical Lake Shore Sensors * | | |
|--|---------------------------------|--------------|
| Diodes | Model | Useful Range |
| Silicon Diodes | DT-670 | 1.4 - 500 K |
| GaAlAs Diode | TG-120 | 1.4 - 475 K |
| Positive Temperature Coefficient (PTC) RTDs | | |
| 100 Ω Platinum RTD | PT-100, 250 Ω full scale | 30 - 675 K |
| 100 Ω Platinum RTD | PT-100, 500 Ω full scale | 30 - 800 K |
| Rhodium-Iron RTD | RF-800-4 | 1.4 - 400 K |
| Negative Temperature Coefficient (NTC) \dagger RTDs | | |
| Germanium RTD | GR-200A-1000 | 2 - 100 K |
| Germanium RTD | GR-200A-250 | 1.2 - 40 K |
| Carbon-Glass™ RTD | CGR-1-500 | 3 - 325 K |
| Cernox™ RTD | CX-1050 AA or SD | 3.5 - 325 K |
| Cernox™ RTD | CX-1030 AA or SD | 2 - 325 K |
| High-Temperature Cernox™ RTD | CX-1030-SD-HT | 2 - 420 K |
| Rox™ Ruthenium Oxide RTD | RX-102A | 2 - 40 K |
| Rox™ Ruthenium Oxide RTD | RX-202A | 3 - 40 K |
| * Sensors sold separately. | | |
| \dagger Single excitation current may limit the low temperature range of NTC resistors | | |

Lakeshore Cryogenics <http://www.lakeshore.com/>

Induced off-set (mK) for neutron and gamma rays

CD - Use of Instrumentation in a Radiological Environment



→ By principle, use redundant system

CERN Test benches:

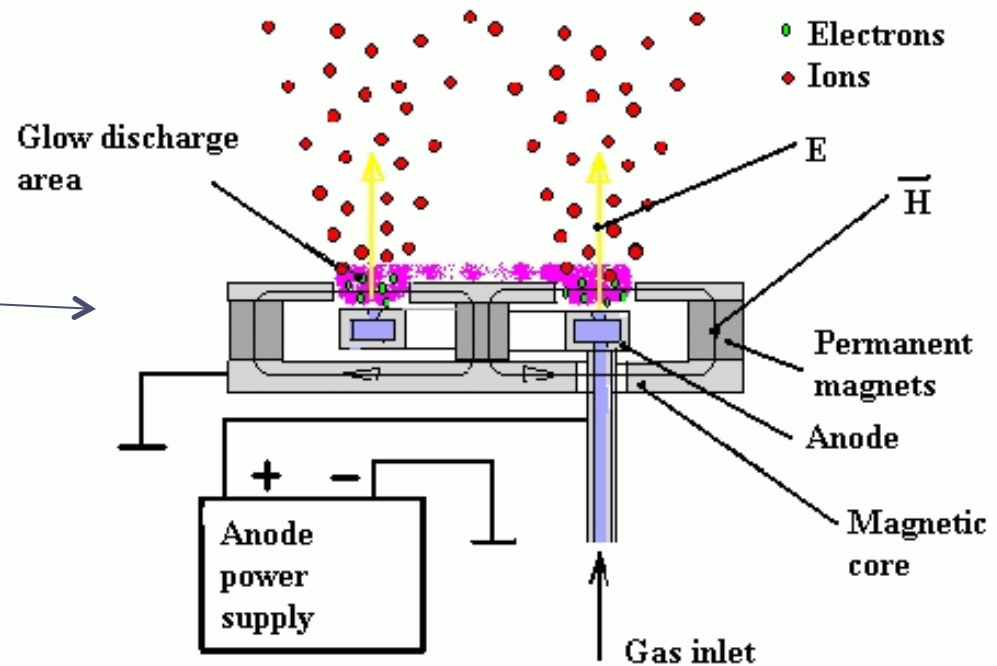
- Thermo cycle
- Irradiation test : fluence values close to 10^{15} neutrons/cm², corresponding to 2.10^4 Gy

| Thermometer (+number tested) | R @ 1.8K | dR/dT @ 1.8K | σ_r @ 1.8K | beam heating mK/(n.cm ⁻² .s ⁻¹) | ΔT Irradiation for $4 \cdot 10^{14}$ n.cm ⁻² | Expected ΔT in LHC |
|---------------------------------|----------------|------------------------------|---------------------|---|--|-------------------------------|
| AB (44) | 6600 Ω | -10600 $\Omega.K^{-1}$ | 8.10^{-5} | $9 \cdot 10^{-10}$ | +2 mK | < 2 mK |
| TVO (44) | 5700 Ω | -3300 $\Omega.K^{-1}$ | $3.3 \cdot 10^{-5}$ | $3 \cdot 10^{-10}$ | +0.3 mK | < 0.5 mK |
| CX (66) | 12600 Ω | -12000 $\Omega.K^{-1}$ | $2.5 \cdot 10^{-5}$ | 10^{-10} | +1 mK | < 2 mK |
| Ge (5) | 9000 Ω | -8000 $\Omega.K^{-1}$ | $1.2 \cdot 10^{-4}$ | 0 | +300 mK | +300 mK |
| RhFe thin-film (46) | 15 Ω | +0.7 $\Omega.K^{-1}$ | 3.10^{-5} | 0 | +12 mK | +3 mK/year |
| RhFe wire (36) | 5.4 Ω | +0.6 $\Omega.K^{-1}$ | $2.6 \cdot 10^{-5}$ | 0 | +5 mK | +1.5 mK/year |
| Pt (22) | 1.7 Ω | +3.5 $10^{-4} \Omega.K^{-1}$ | - | - | +1.5 K | - |

Table 1 Results of irradiation at 1.8 K (average values)

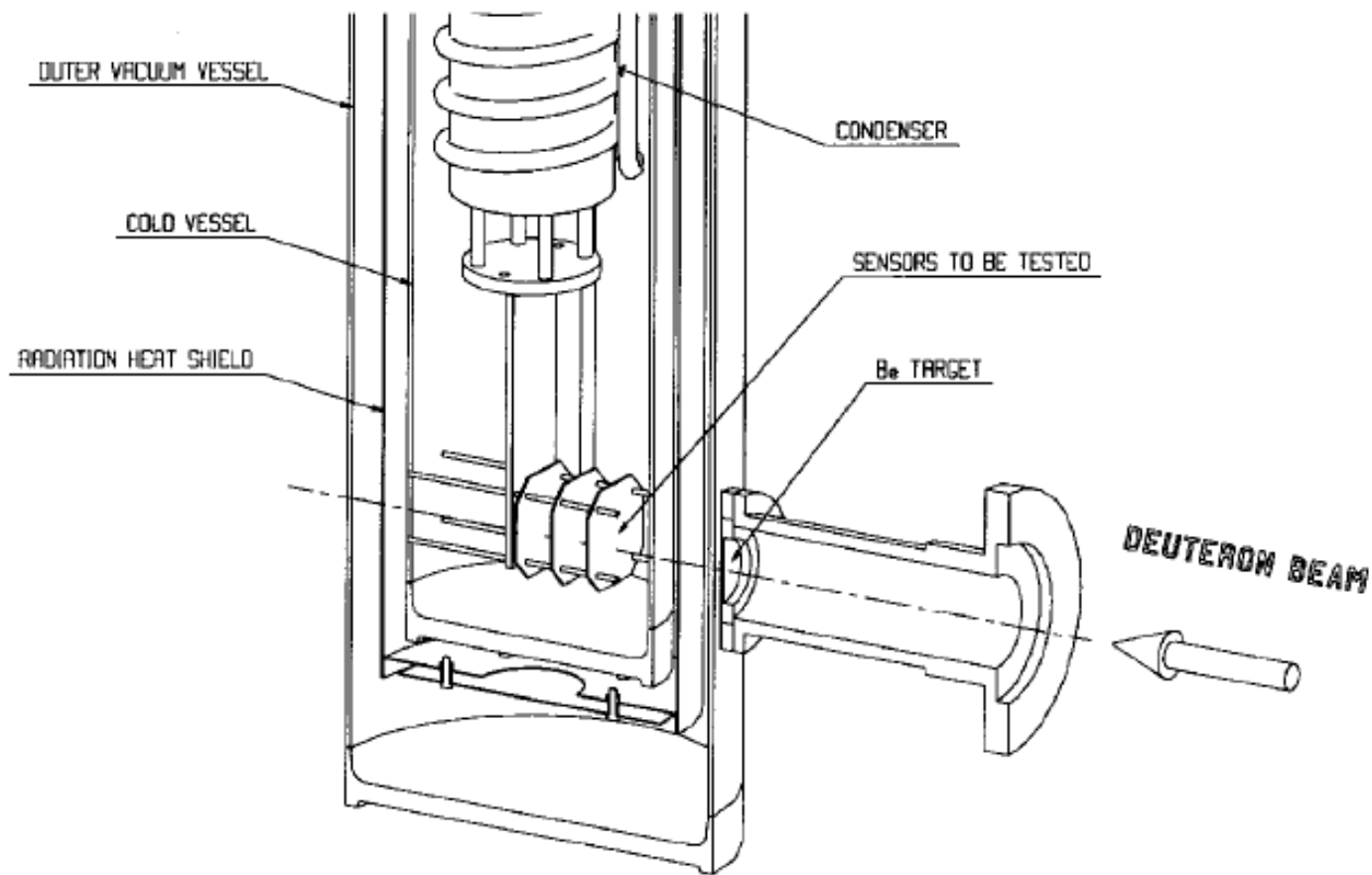
Ref: "Neutron irradiation tests in superfluid helium of LHC cryogenic thermometers" by Amand,, et. al., International Cryogenic Engineering Conference - 17, Bournemouth, (1998), 727-730

- Type: Absolute, differential, gauge
- Vacuum gage, e.g. cold cathode
- Problems with room temperature pressure measurement
 - Thermal acoustic Oscillations
 - Time response
- Some cold pressure transducers exist
- Capacitance pressure sensors

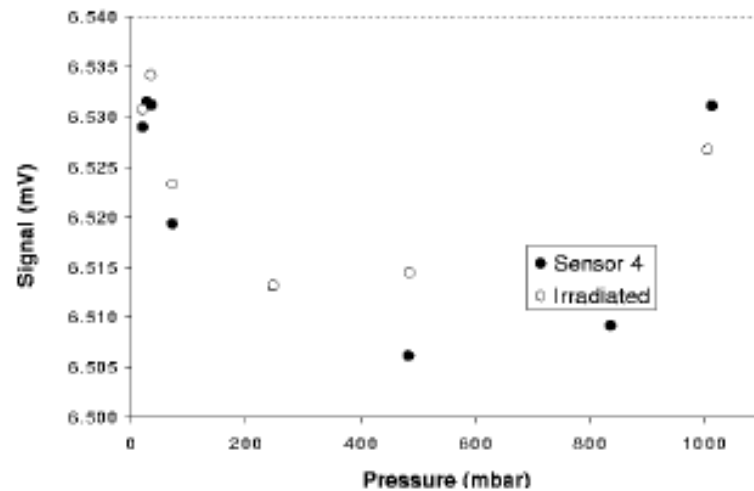
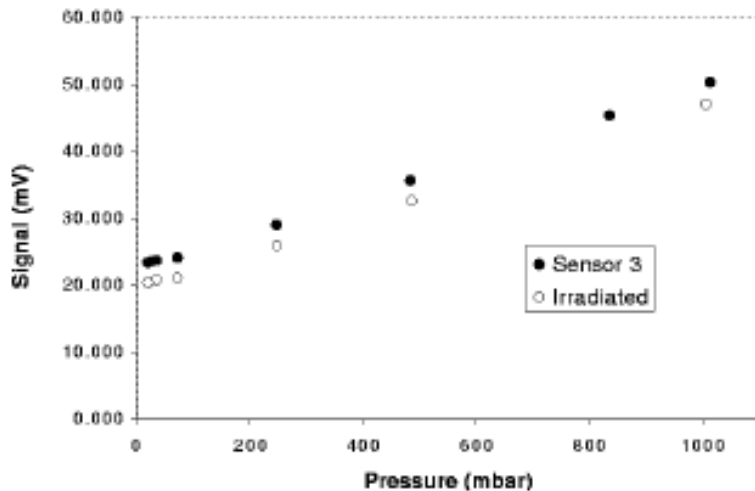
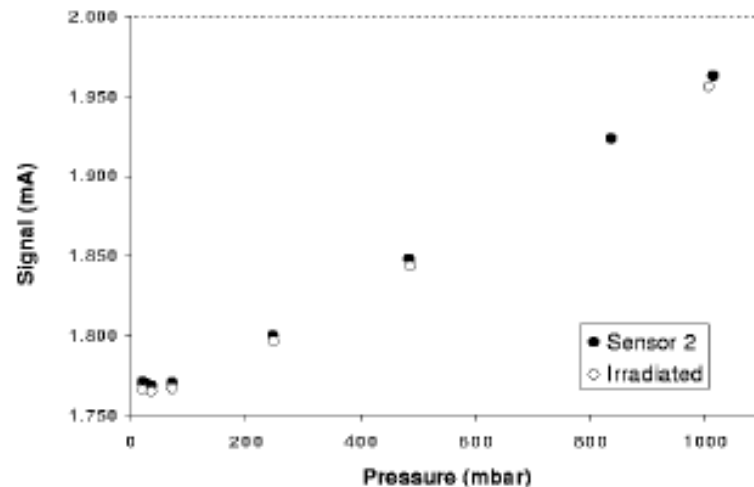
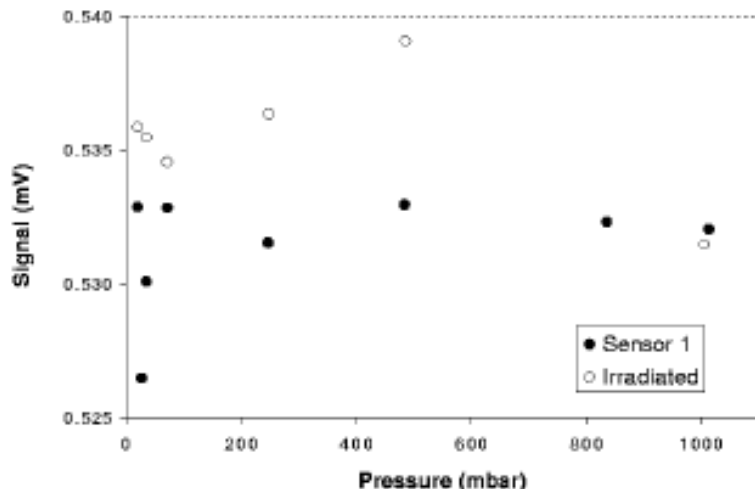


Pressure Measurement – Irradiation Test

Irradiated by neutrons (1-20 MeV, 10^{15} n/cm²) → 10 years of LHC operation at full intensity



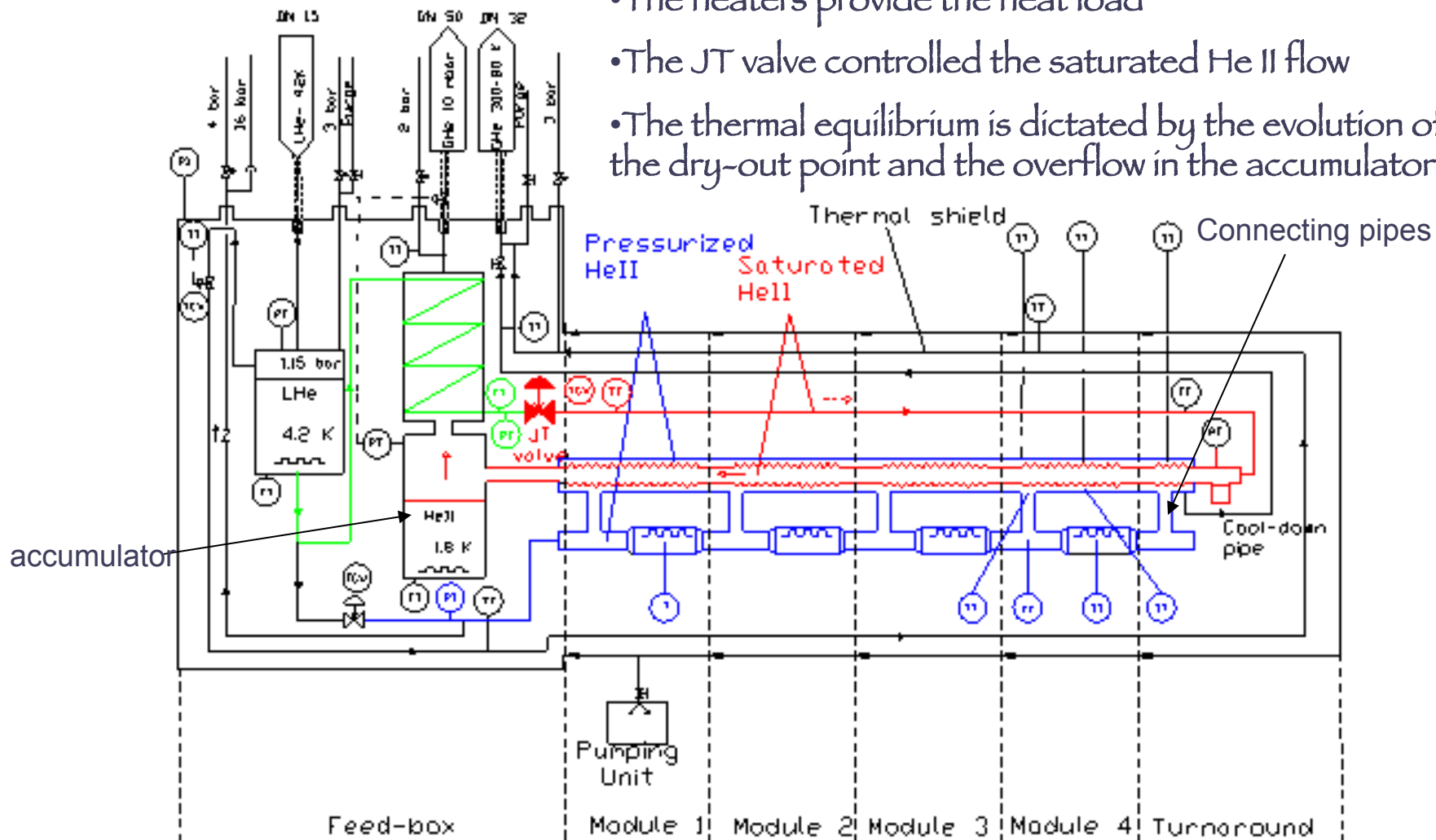
Pressure Measurement – Irradiation Test



Ref: Amand,, et. al., *Neutron Irradiation Tests of Pressure Transducers in Liquid Helium*, *Advances In Cryogenic Engineering* (2000) , *45B*, 1865-1872

Example 1: HXTU - Process and Instrumentation Diagram

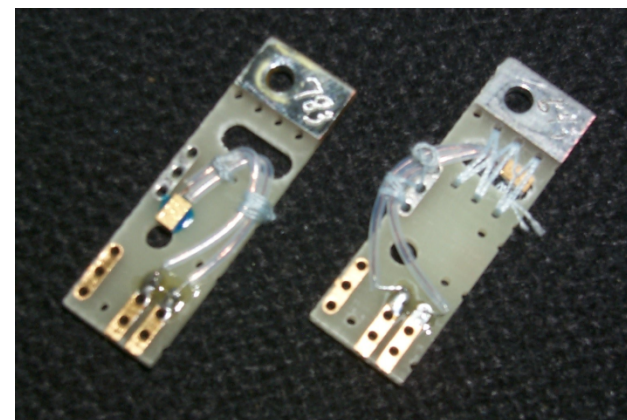
- The heaters provide the heat load
- The JT valve controlled the saturated He II flow
- The thermal equilibrium is dictated by the evolution of the dry-out point and the overflow in the accumulator



| Instrumentation | Total | Range | Accuracy |
|-----------------------------------|-------|-----------------------------------|-----------------------|
| Temperature (Cernox®, Pt100) | 54 | 1.6 – 40 K, 50 K – 300 K | ± 5 mK, ± 5 K |
| Pressure (Absolute, Differential) | 5 | 0-1.3 bar, 0-0.13 bar, 0-7.5 mbar | 0.2%, 0.03 mbar |
| Level (AMI) | 5 | 0-6", 0-12", 0-28" | $\pm 2\%$ FS |
| Flowmeter (Turbine+RT) | 2 | 0-20 g/s | $\pm 2\%$ FS |
| Heaters (Electrical resistances) | 12 | 55, 90, 240 Watts | |
| Control Valves | 6 | 0-100 % | |

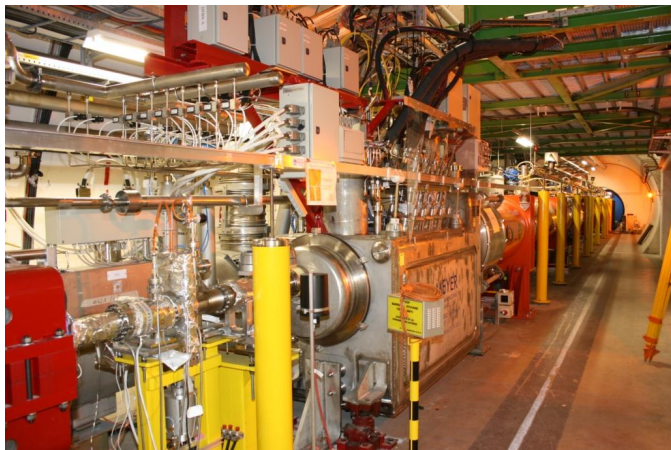
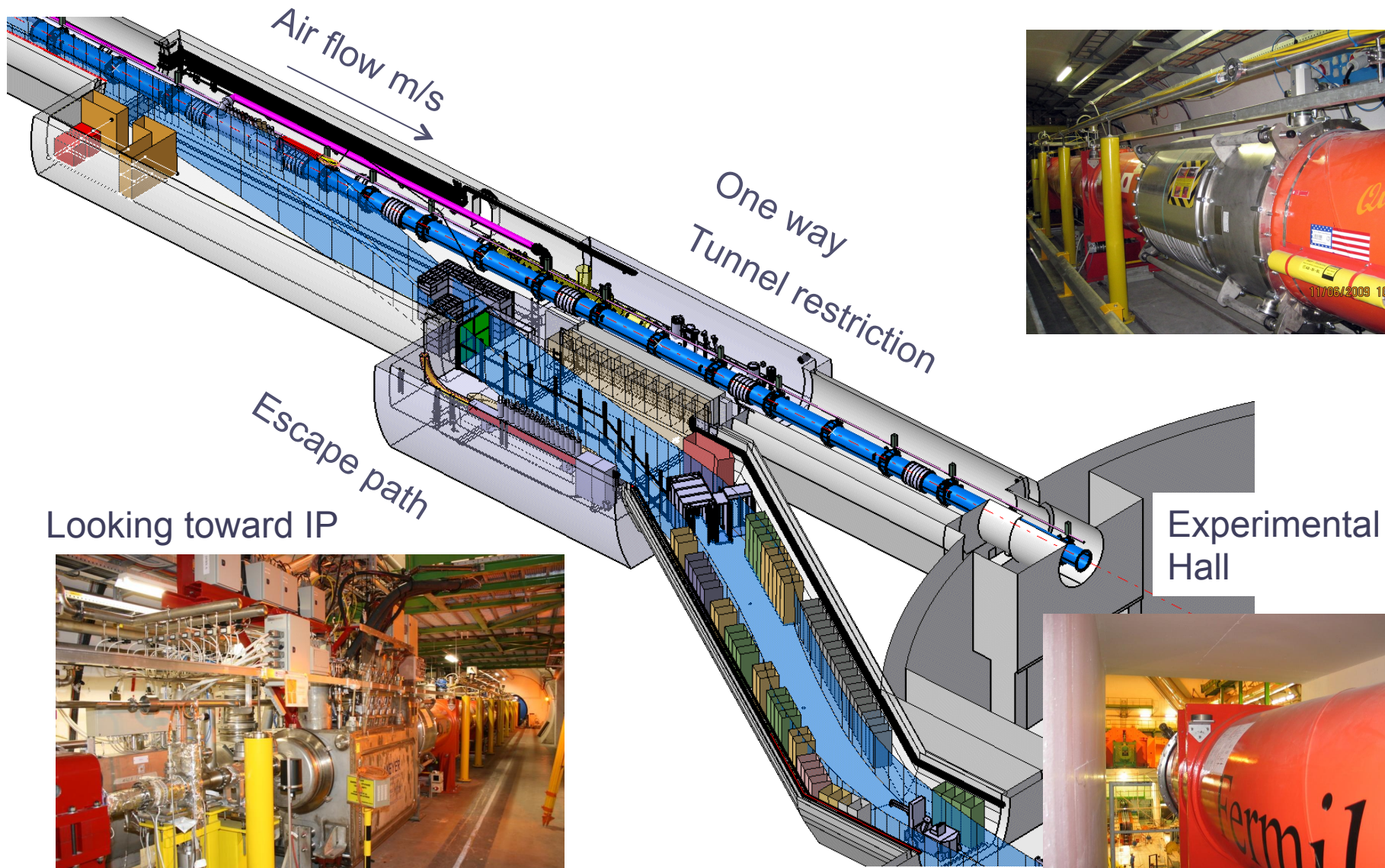
Temperature sensors implemented in the pressurized He II bath

- Error of +/-5 mK on the temperature measurements.
- Stainless steel tubes to route the wires.





Underground views : 80-120 m below ground level



Looking toward IP

Experimental Hall

The low- β magnet system safety specification

Design and operation requirements:

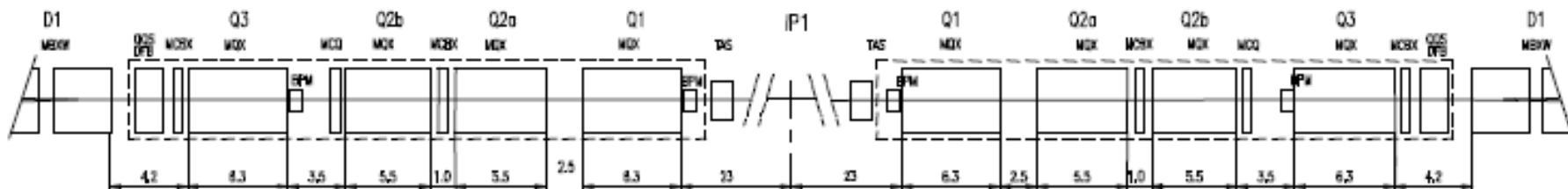
- Critical system for LHC performance, but the system operation and maintenance should remain **safe for personnel and for equipment**,
e.g. escape path, absorbed radiation dose, embrittlement, polymer prop. decay.
- Equipment, instrumentation and design shall comply with the CERN requirements,
e.g. ES&H, LHC functional systems, Integration
- Risks identified: Mechanical, electrical, cryogenics, radiological

Cryogenic risk \rightarrow FMEA, Use the Maximum Credible Incident (MCI)

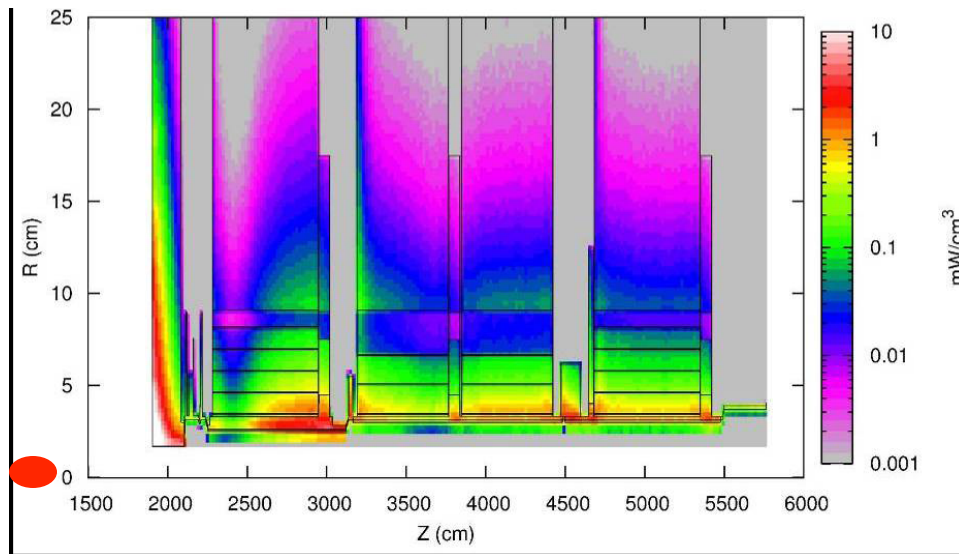
Radiological \rightarrow Use **materials resistant to the radiation rate** permitting an estimated machine lifetime, even in the hottest spots, exceeding 7 years of operation at the baseline luminosity of $10^{34}\text{cm}^{-2}\text{s}^{-1}$.

Personnel safety: Keep residual dose rates on the component outer surfaces of the cryostats **below 0.1 mSv/hr**.

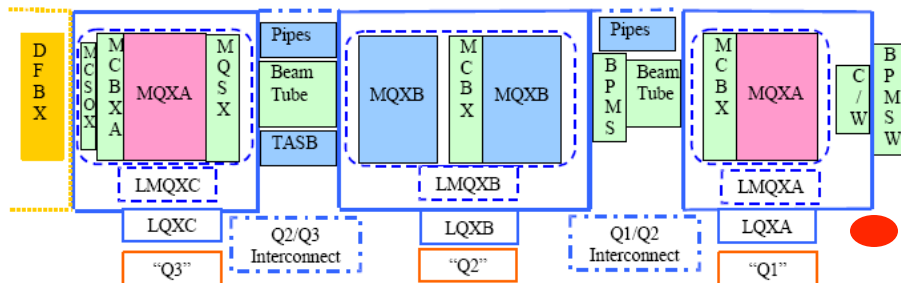
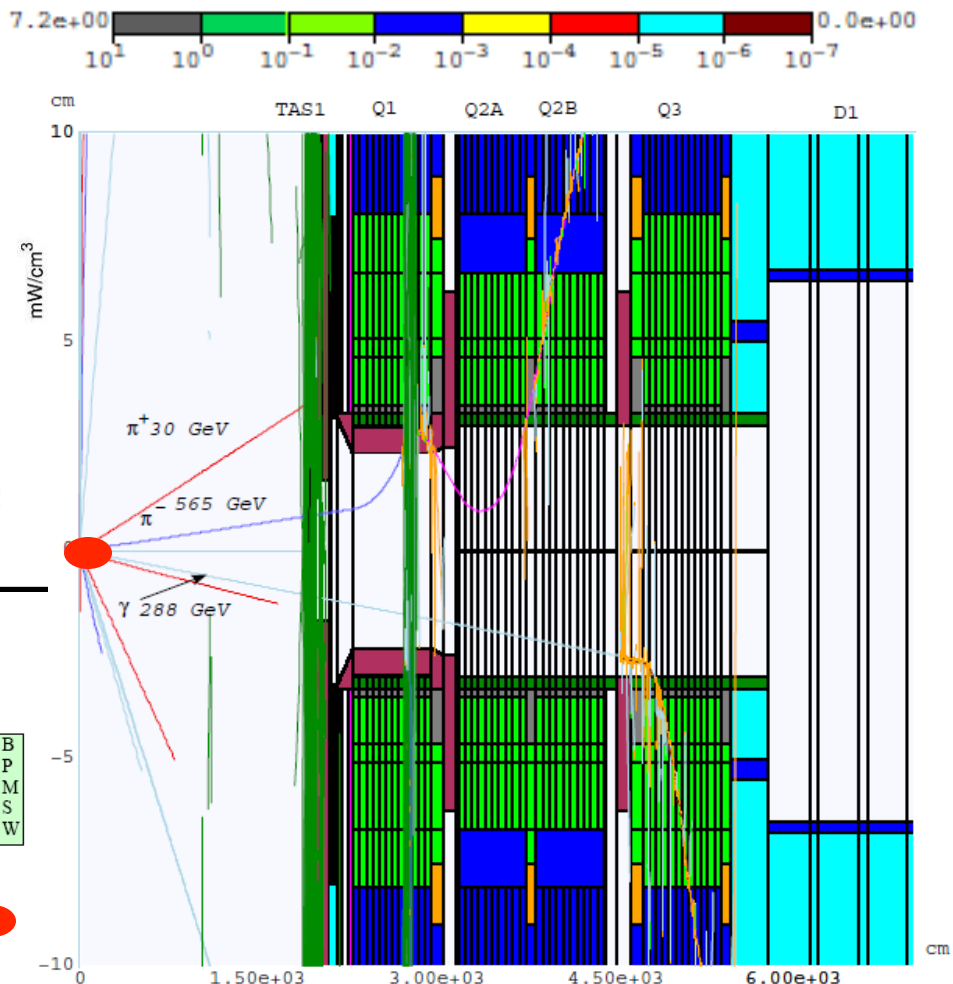
Apply the **ALARA** principle (As Low As Reasonably Achievable).

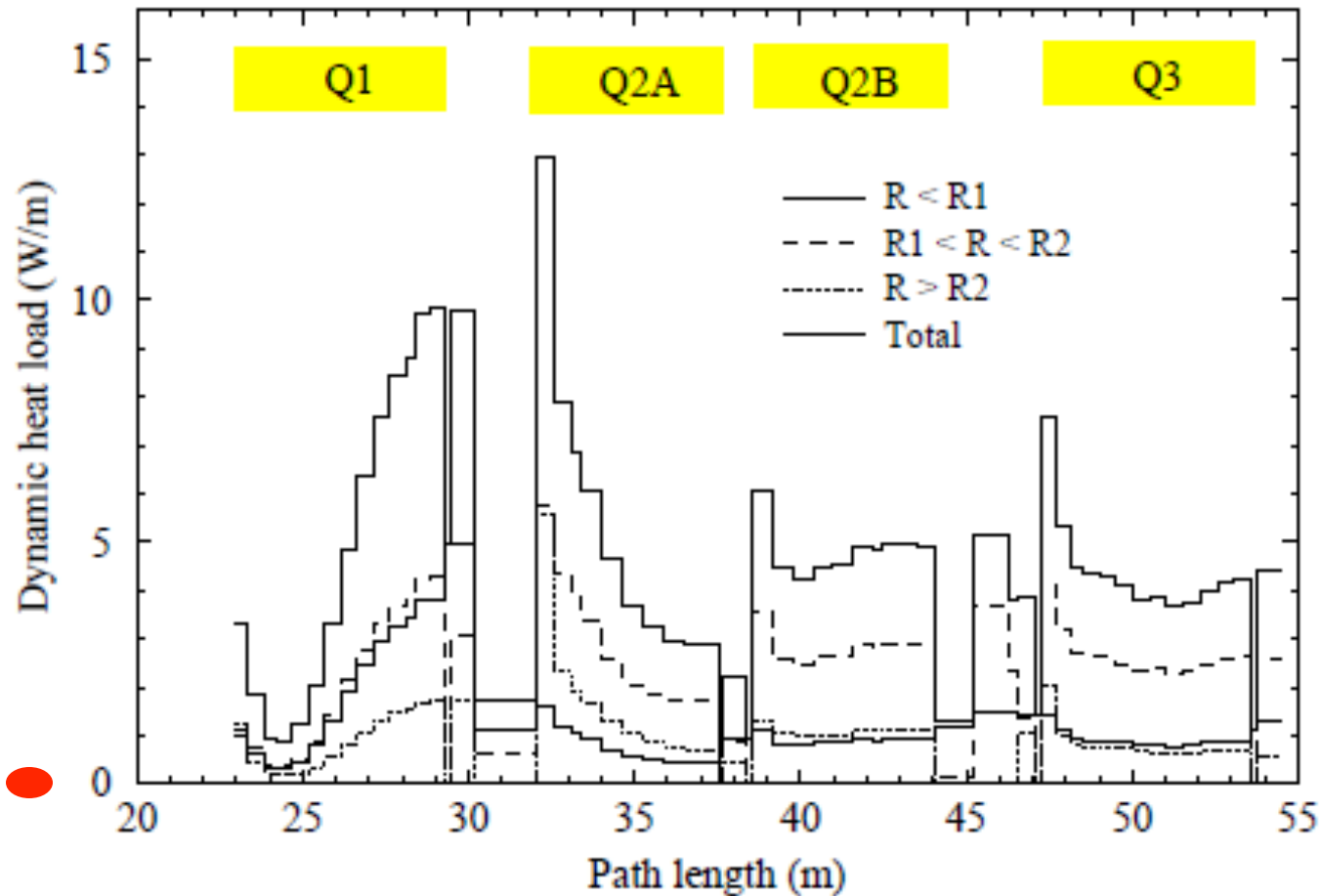


IR5 azimuthally averaged power distribution.

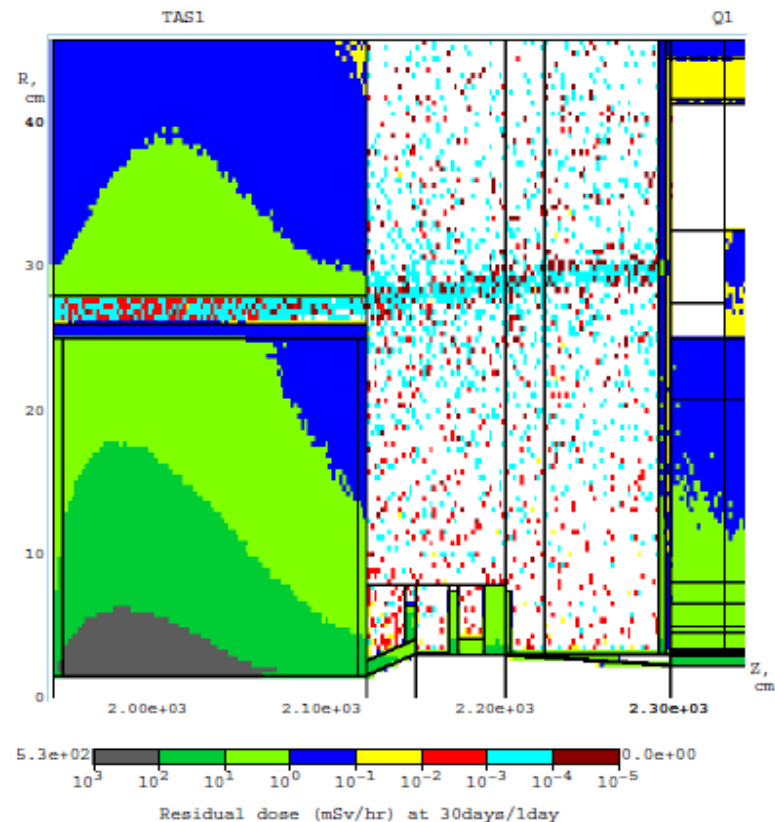
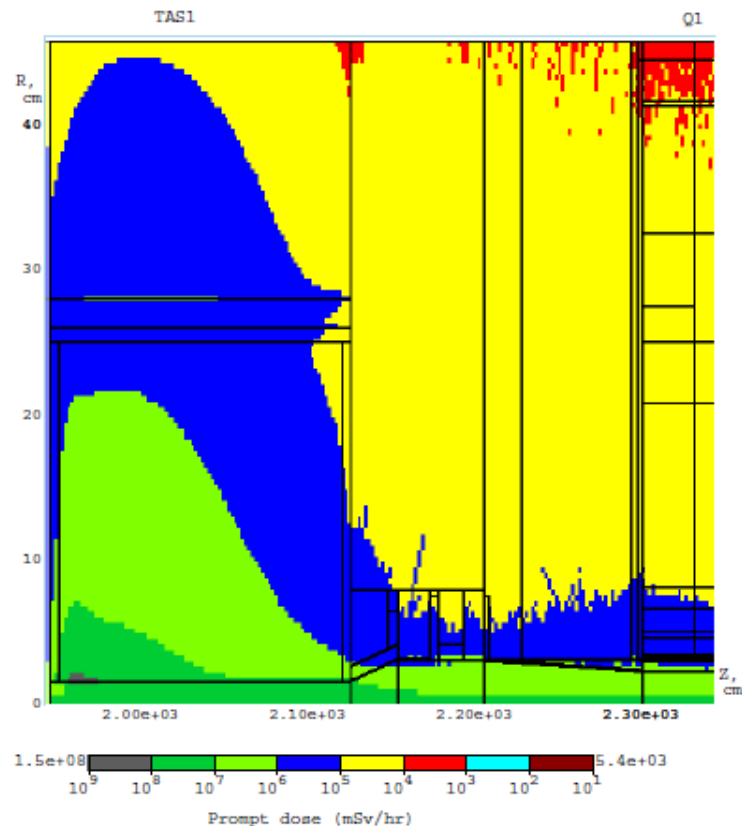


Particle tracks reaching the inner triplet and those generated there for a pp -collision in the IP1





Power dissipation in the baseline IP5 inner triplet components. $R1=35$ mm, $R2=81$ mm in Q1 and Q3 and $R2=67$ mm in Q2a and Q2b



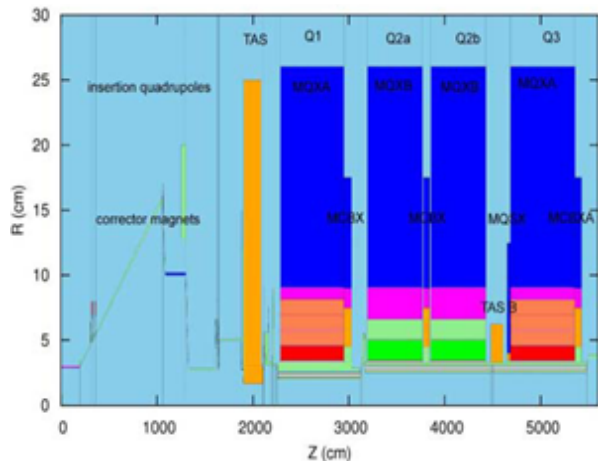
Azimuthally averaged prompt dose equivalent (left) and residual dose rate on contact after 30-day irradiation and 1-day cooling (right) in mSv/hr in the TAS-Q1 region at the baseline luminosity

→ The maximum of 12.5 mW/g (or 100 MGy/yr) at 15 cm (z=1960 cm) is determined by photons and electrons coming to the absorber

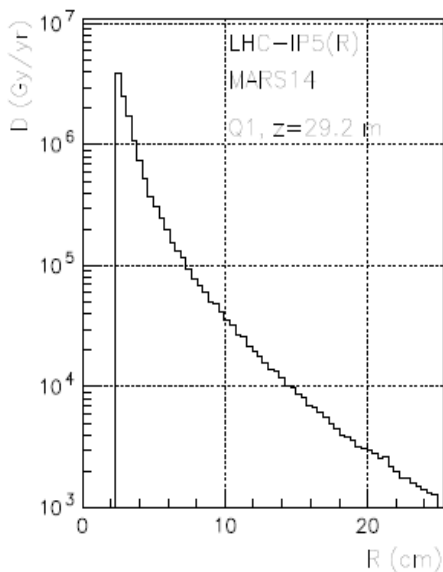
Radiological risk

“Protecting LHC IP1/IP5 Components Against Radiation Resulting from Colliding Beam Interactions”, by N.V. Mokhov et. al

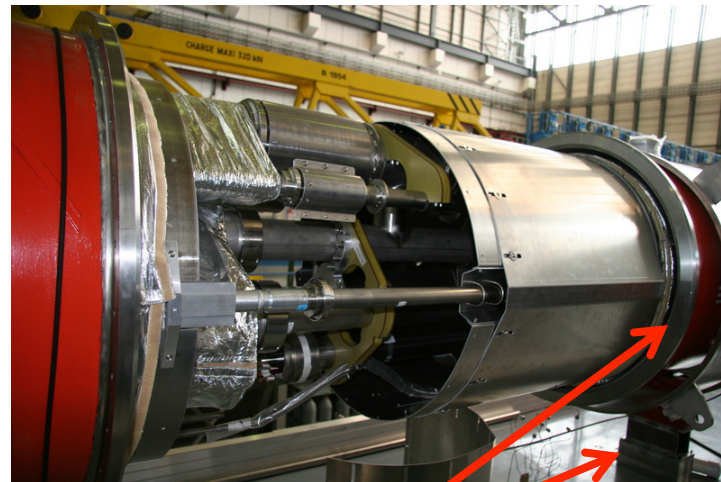
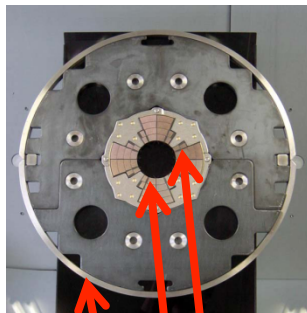
IR5 azimuthally averaged power distribution



Radial distribution of azimuthally averaged dose (Gy/yr)



→ Magnet quench limit = 1.6 mW/g

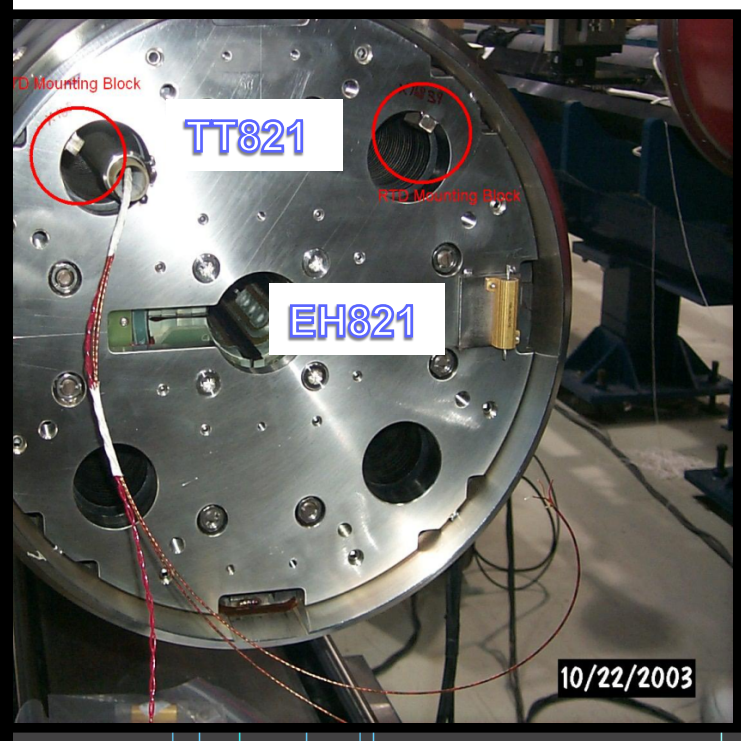
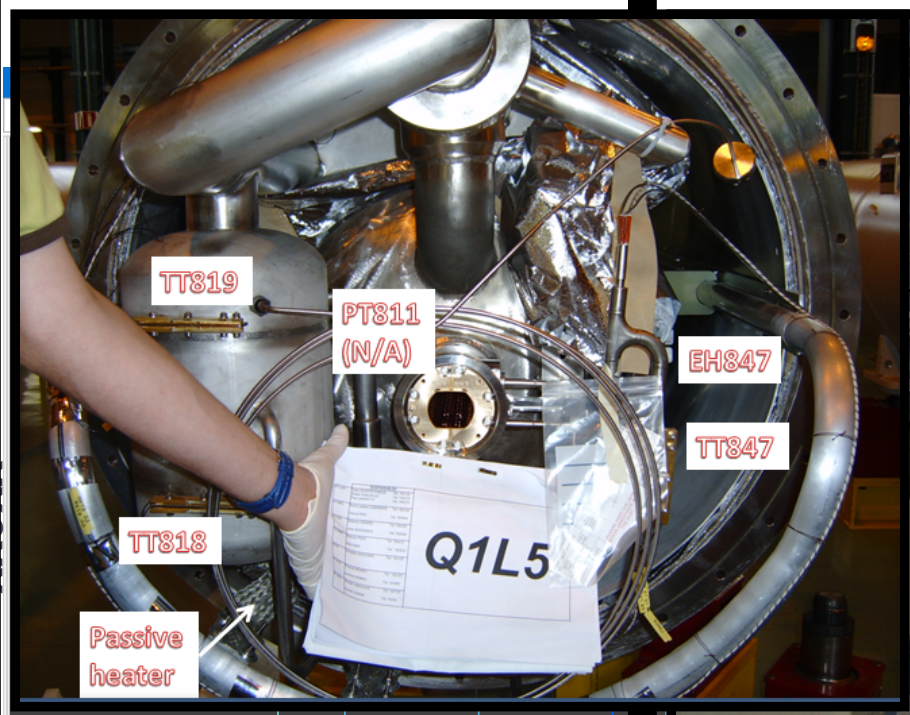


| Element | z-region (m) | P (W) | D (kGy/yr) |
|------------|---------------|-------|------------|
| Pipe | | 0.841 | |
| Bore | | 1.994 | |
| Helium | 54.45-58.83 | 0.108 | 523.2 |
| Jack | | 0.936 | 310.6 |
| Ins+vessel | | 0.488 | |
| r=9 cm | | 1.014 | 74.18 |
| r=15 cm | 54.485-58.795 | 0.470 | 20.85 |
| r=30 cm | | 0.272 | 6.074 |

For comparison : Arc magnet ~ 1 Gy/yr

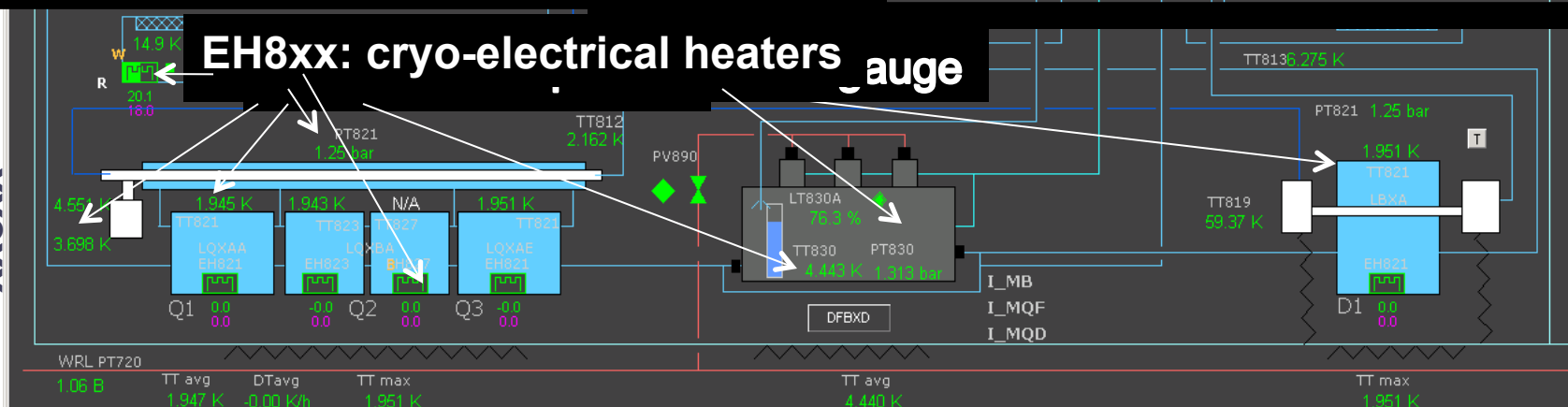
Type of instrumentation

Interface with QRL



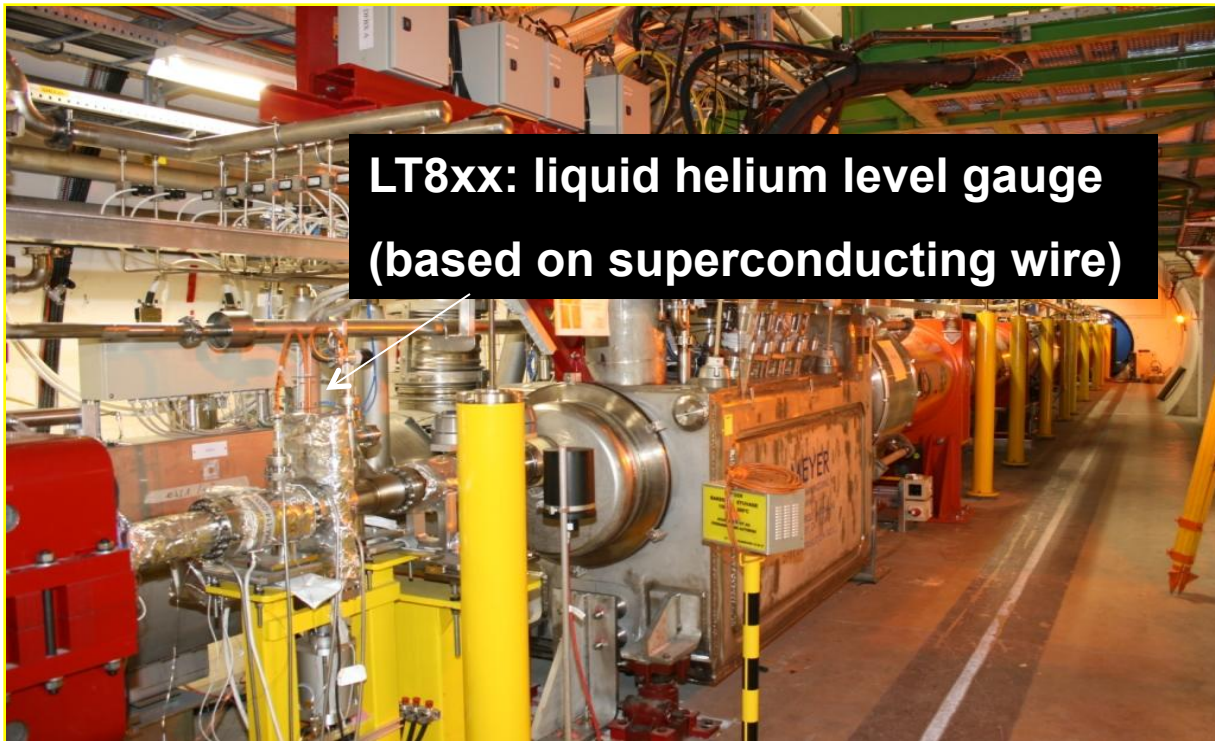
Low-β system

xx8xx

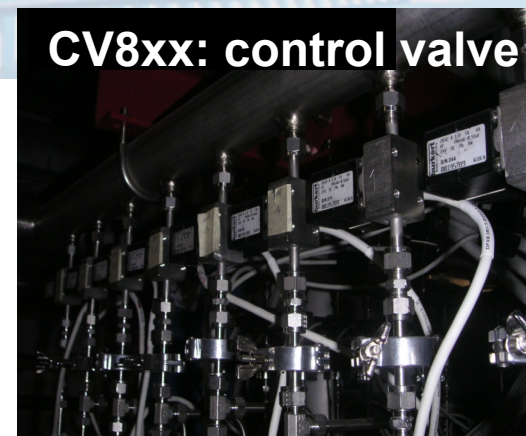




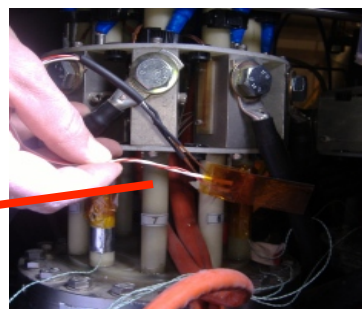
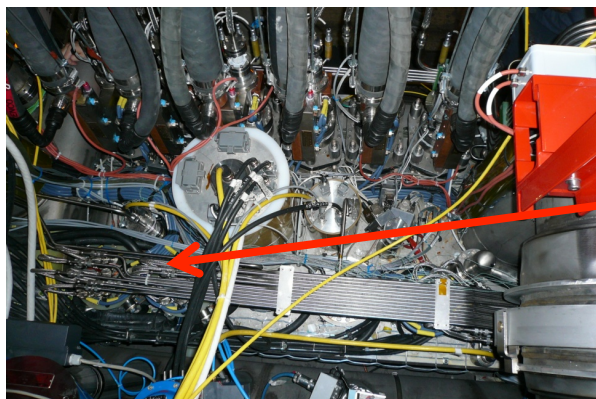
Type of instrumentation



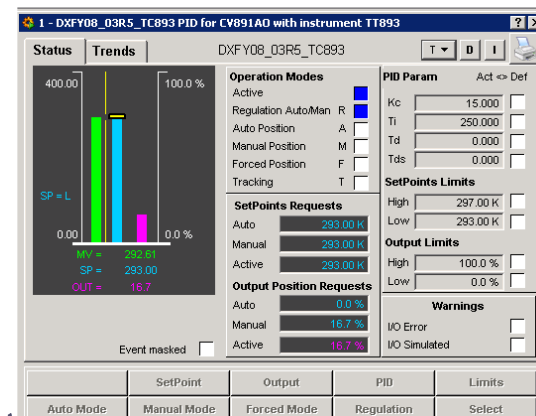
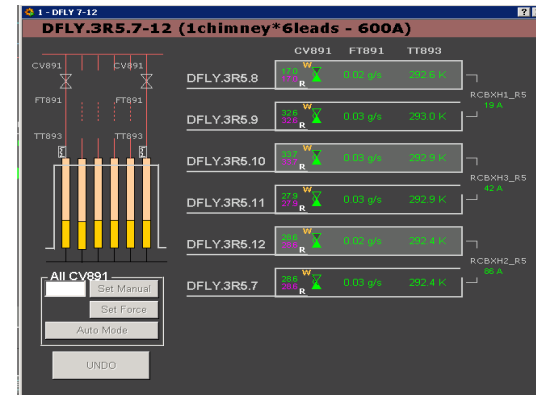
LT8xx: liquid helium level gauge (based on superconducting wire)



CV8xx: control valve

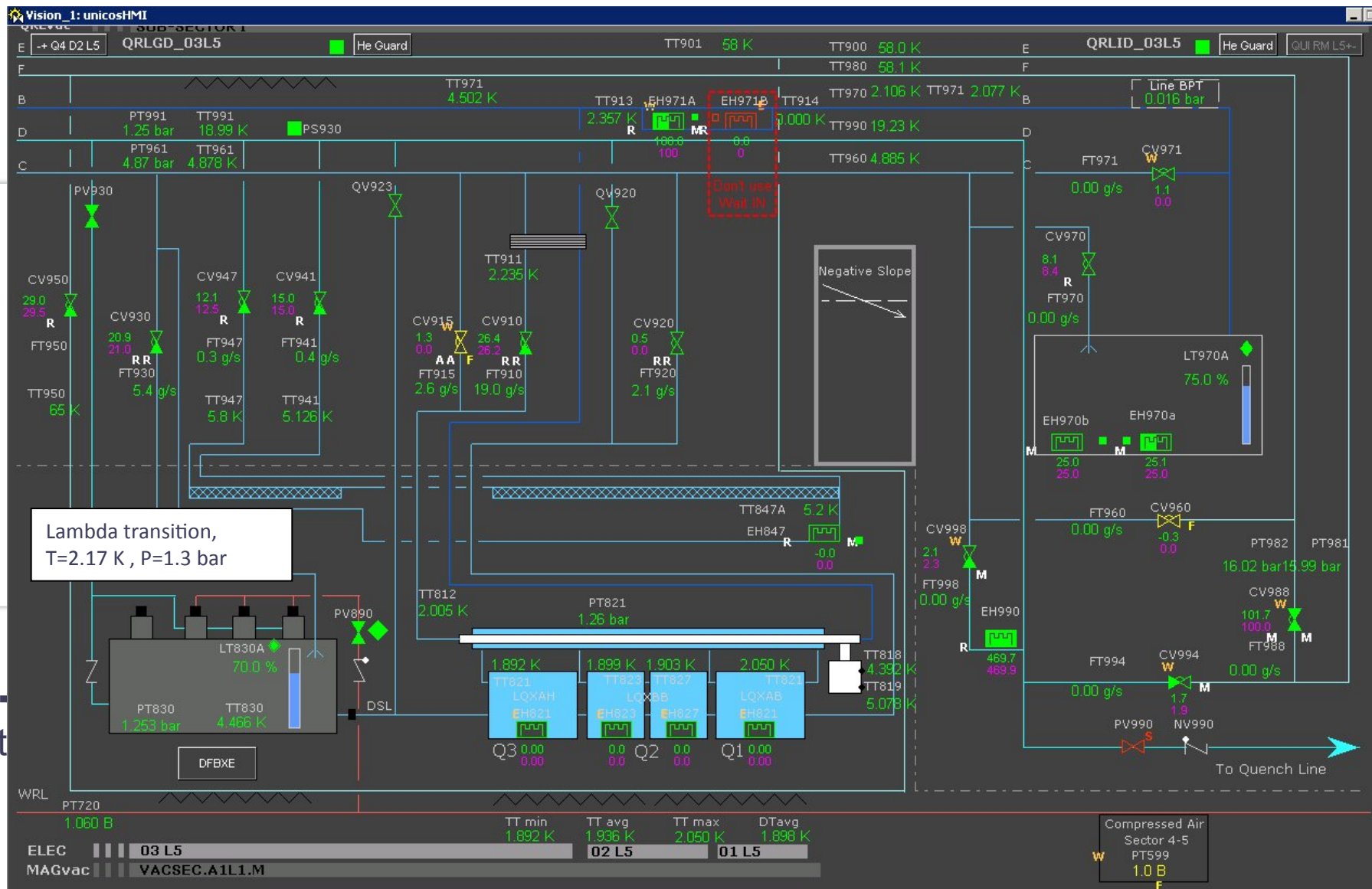


- *HTS leads
- *VCL leads
- *Inner triplet feed through





Reliability – Performance measurement



In order to compare energy deposition results with FLUKA 2006.3 and MARS 15

Energy deposition in GeV/primary, for proton-proton collision.

$$\text{Power} = \text{Energy} \cdot 10^9 \cdot 1.602 \cdot 10^{-19} \cdot L \cdot A \cdot 10^{-24}$$

L = luminosity in collisions $\cdot 10^{35} \text{ cm}^{-2} \text{ s}^{-1}$

A = reaction cross section (including inelastic scattering and single diffraction events) in barn (80 mbarn)

| IR Elements | FLUKA | MARS |
|------------------------|--------|--------|
| TAS | 1853.7 | 1827.3 |
| Beam pipe | 89.1 | 97.9 |
| Q1 cable | 158.0 | 159.1 |
| Q1 yoke | 96.3 | 78.5 |
| Aluminium layer | 2.3 | 2.4 |
| Insulation | 19.5 | 20.4 |
| Stainless steel vessel | 16.8 | 17.3 |

$$\rightarrow \text{Power [W]} = 1.28 \cdot \text{Energy [GeV/collision]}$$

$$\text{Power density [mW/cm}^3 \text{]} = 1280 \cdot \text{Energy [GeV/cm}^3 \text{/collision]}$$

Comparison of total heat loads (W), upgrade luminosity $L=10^{35} \text{ cm}^{-2} \text{ s}^{-1}$

IR Elements FLUKA MARS

- The inner-triplet final design included **additional radiation shielding** and **copper absorber (TAS)**
- The chosen instrumentation and equipment are **radHard** and **halogen free** (neutron irradiation experiment performed on temperature sensors : fluence values close to 10^{15} neutrons/cm², corresponding to $2 \cdot 10^4$ Gy).
- **PEEK** versus Kel-F material used for the DFBX low temperature gas seal
- **LHC tunnel accesses modes** were defined, e.g. control and restricted modes

- Specific **hazard analysis** is requested to intervene on **the low-b systems**

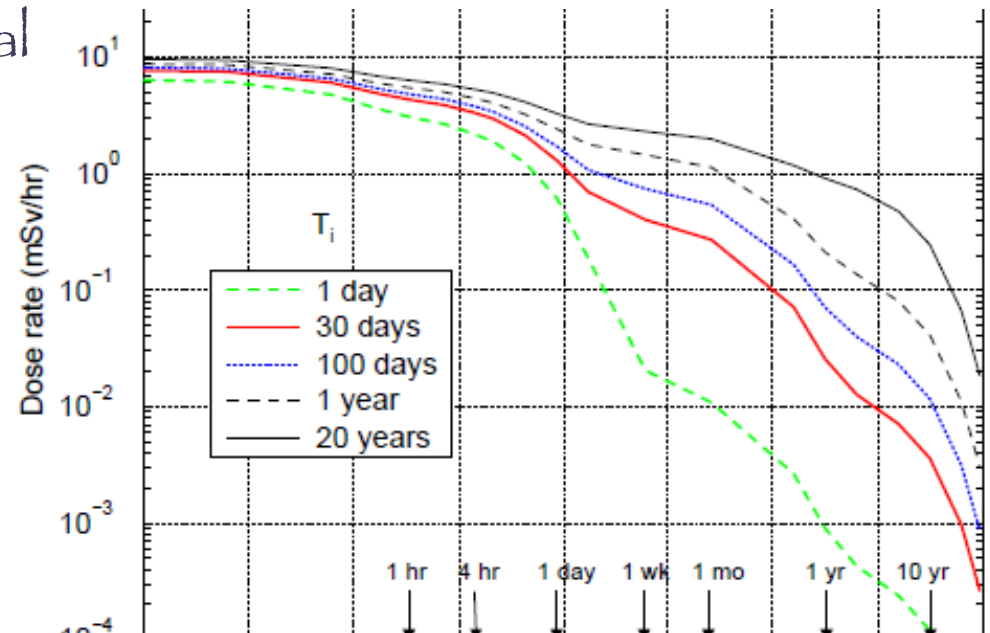
- **Radiological survey** systematical performed ($< 1 \text{ mSv/hr}$)

- **Procedures** written based on lessons learned

- **Limit the personnel exposition time**

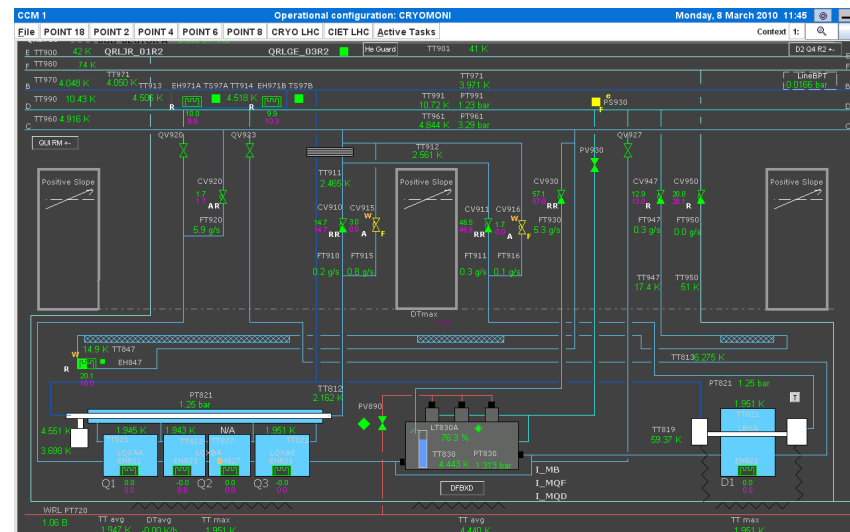
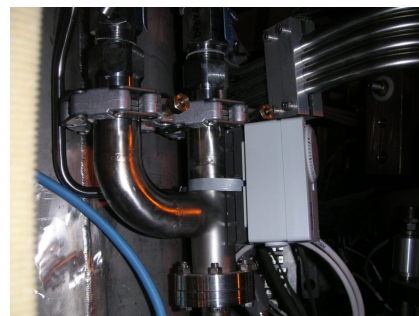
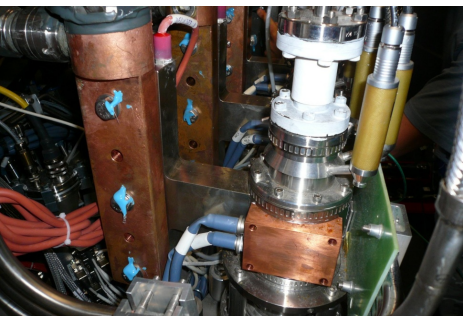
- Process control w/ **interlocks** and **alarm** level for each operating mode

Averaged over surface residual dose rate (mSv/hr) on the Q1 side ($z=2125 \text{ cm}$, bottom) of the TAS vs irradiation and cooling times. *By courtesy of N. Mokhov*



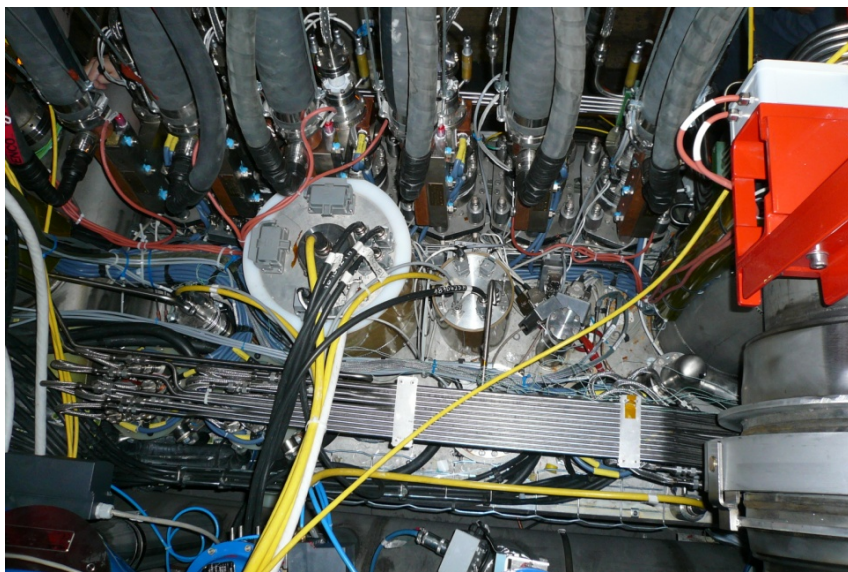
Risk mitigation: control operation upsets

- The so-called “Cryo-Start” and “Cryo-Maintain” threshold were tuned
- **Temperature switch** ultimately protect the operation of the **HTS leads** by using the power converter
- Temperature switch on the **safety relief valve** to monitor possible helium leak
- **Interlocks** on insulating vacuum pressure measurement
- DFBX Vapor Cooled Lead (VCL) voltage drop is 160 mV
- If **pressure in the helium distribution line** rise, then isolate DFBX (w/ low MAWP)

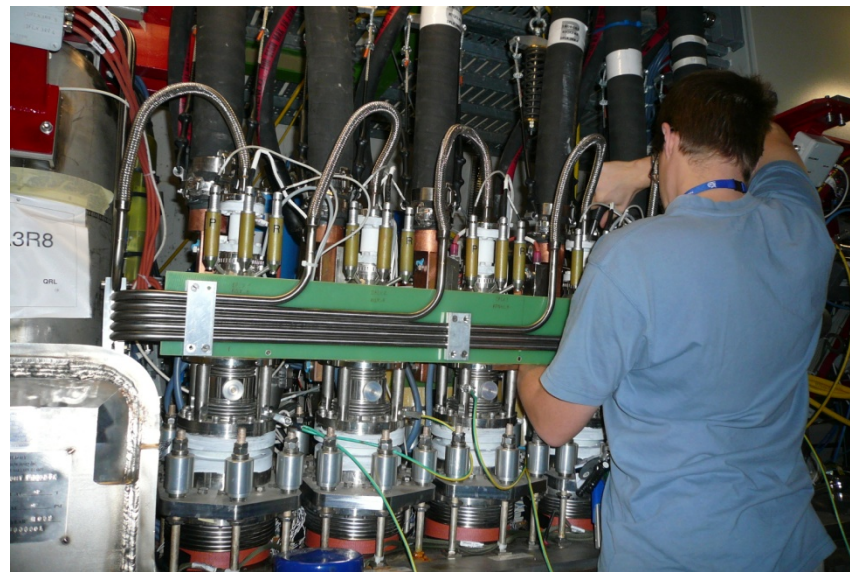


Risk mitigation : personnel training

- In addition to the use of software and hardware interlocks to limit risks, personnel's training is of prime importance.
- New classes comply with the CERN safety policy. They train the personnel to behave safely in a cryogenic and radiation environment.
- **Awareness and preventive** actions are mandatory to complete each technical task. Dedicated hazard analyses are enforced to work in the low-b magnet system area.



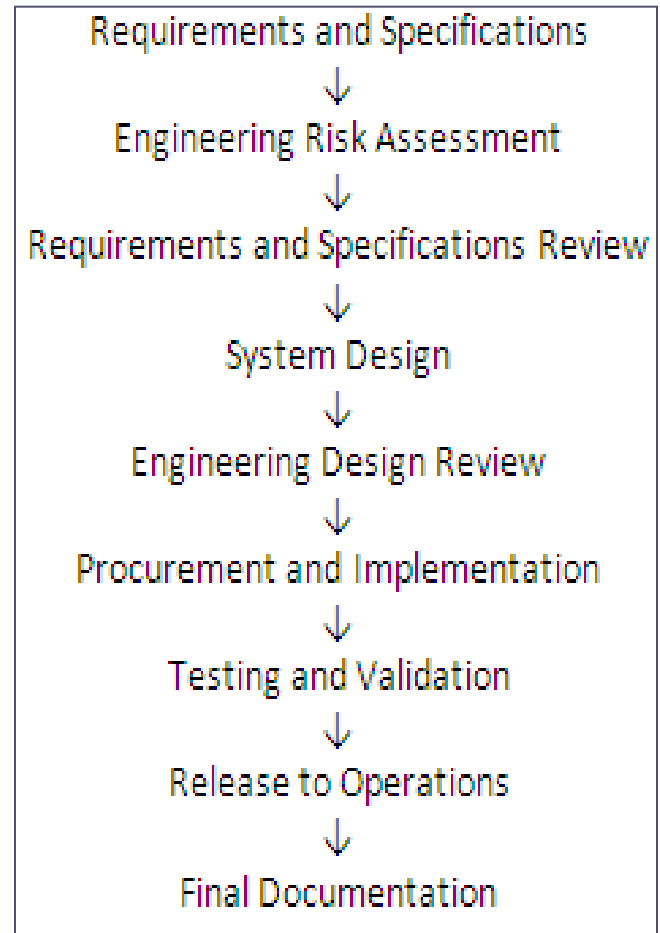
“Compact” DFBX area



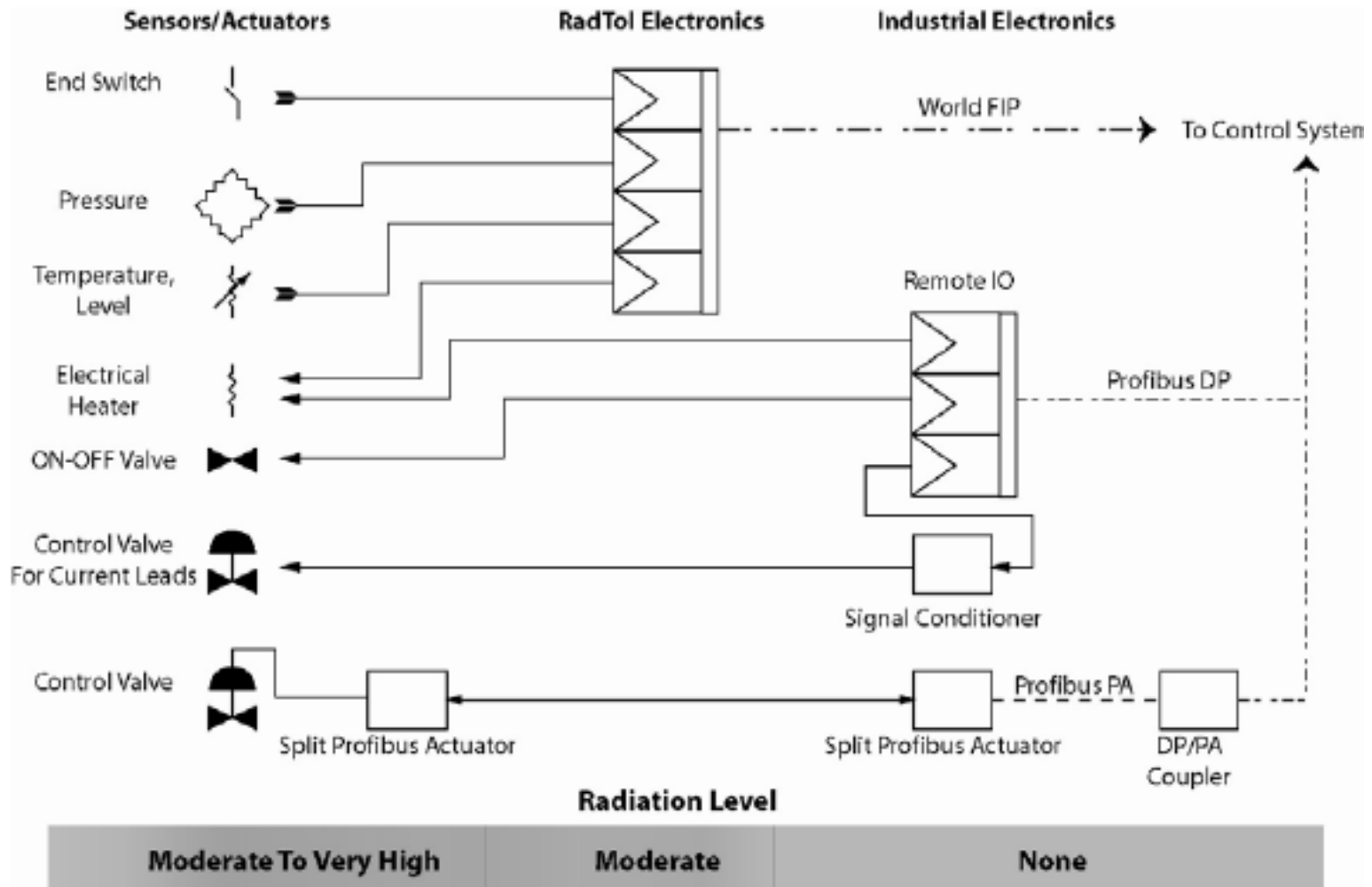
Opening to a new Engineering process approach:
A new engineering manual was issued at Fermilab:

- This **risk-based graded approach** provides safe, cost-effective and reliable designs.
- The implementation flexible to loop within the given sequences.
- The implementation of this process will be adjusted to the Fermilab future projects

Engineering Process sequences

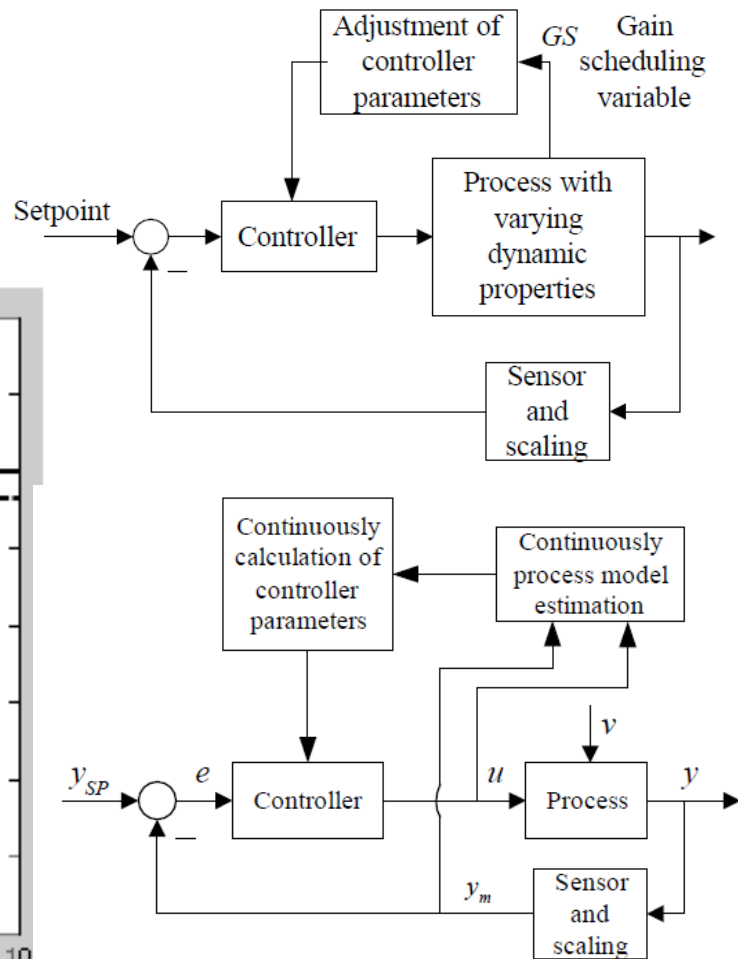
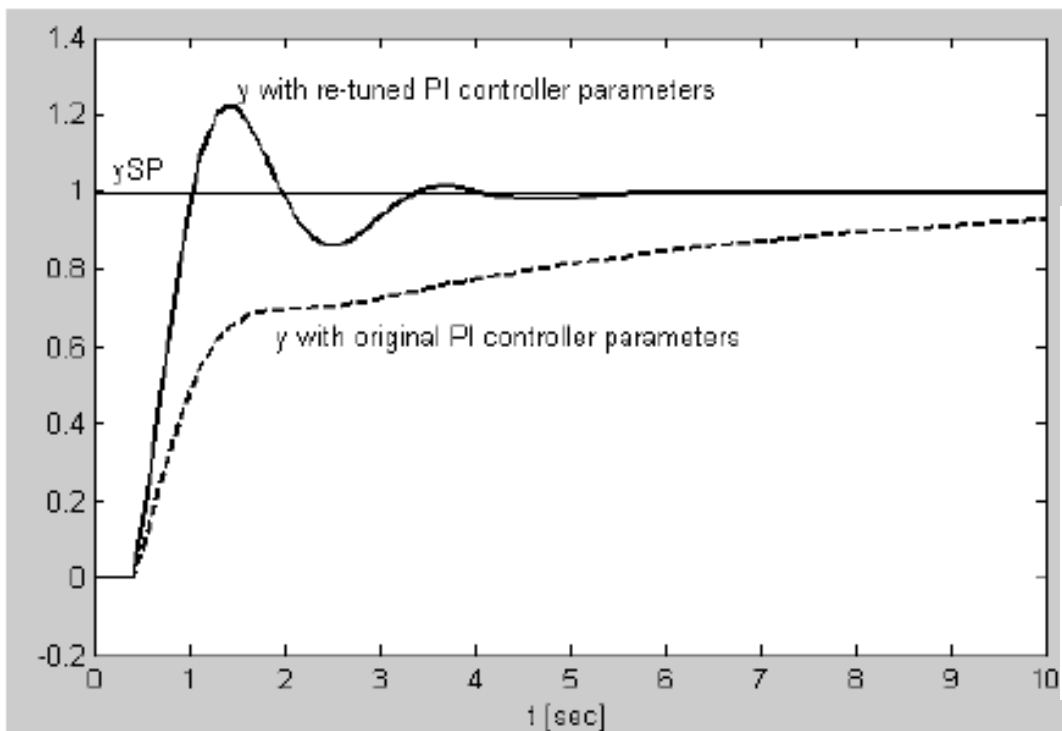


Cryogenic Instrumentation Identification



Ref: "First Experience with the LHC Cryogenic Instrumentation", by N. Vauthier et al, LHC Project Report 1078, 2007

Example: Response in process output for control system with original and re-tuned PI controller parameters





Availability : Data flow & LHC Logging Cryogenics Data

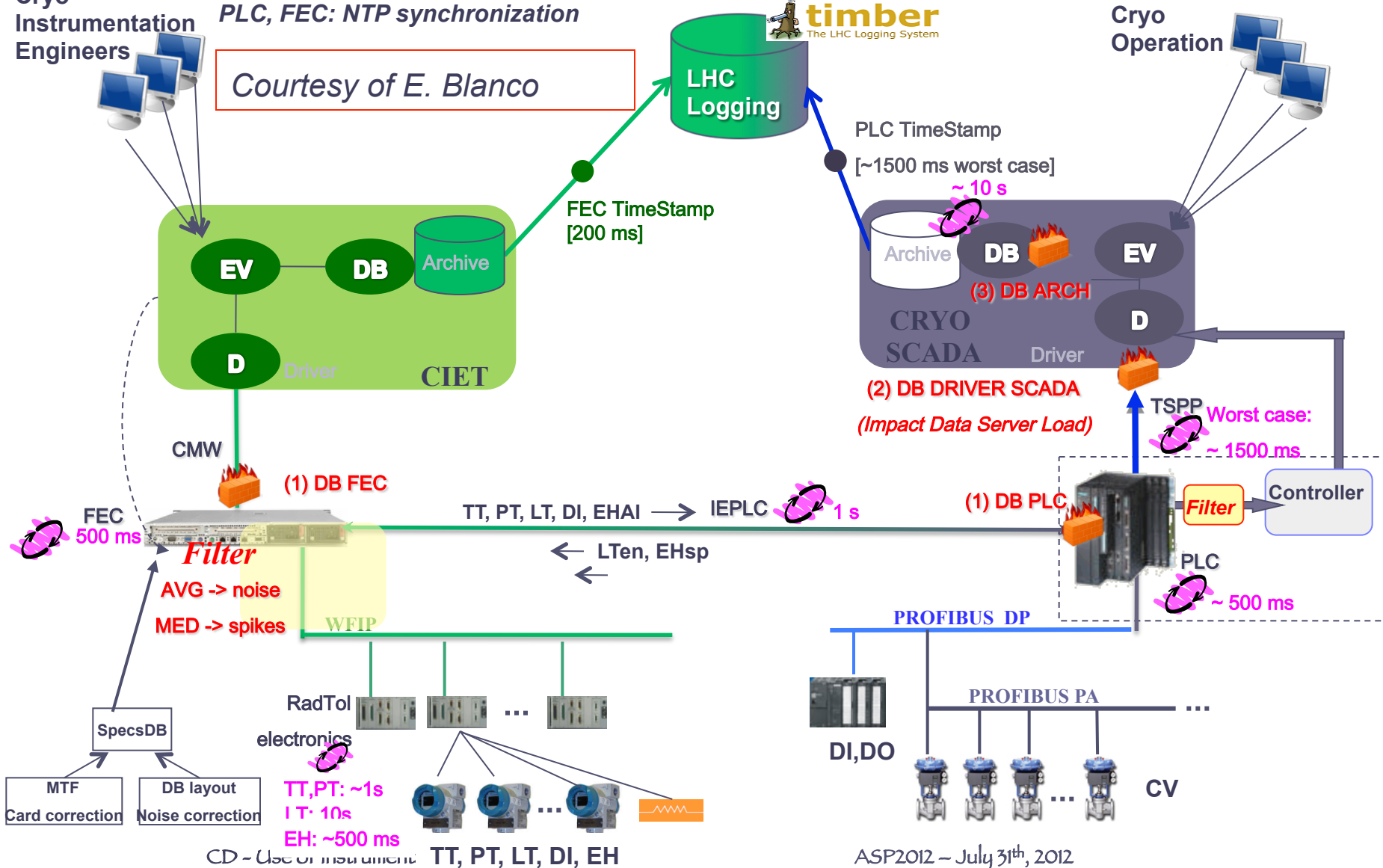
Cryo Instrumentation Engineers

PLC, FEC: NTP synchronization

Courtesy of E. Blanco



Cryo Operation



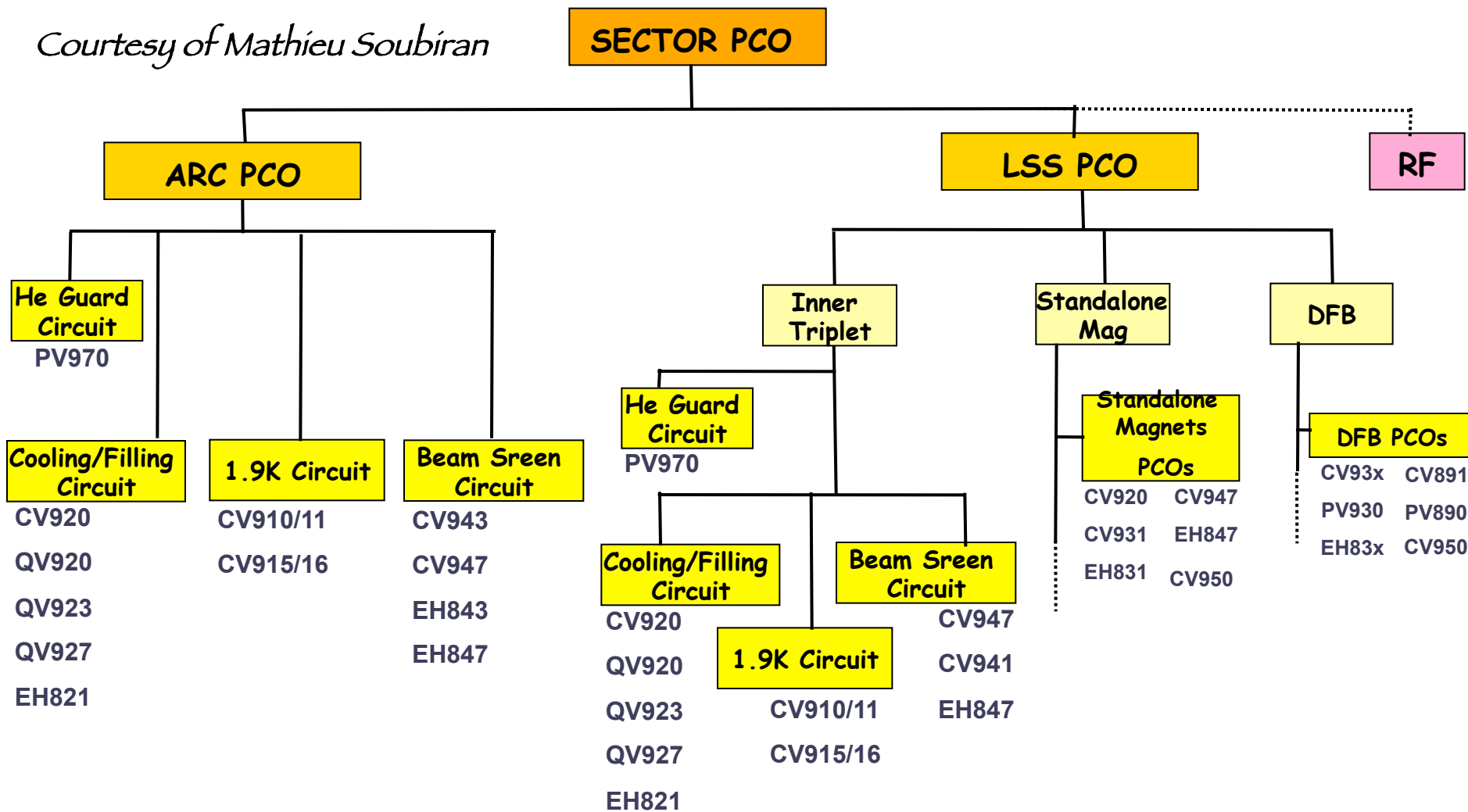
CD - Use of instrument TT, PT, LT, DI, EH

ASP2012 - July 31th, 2012

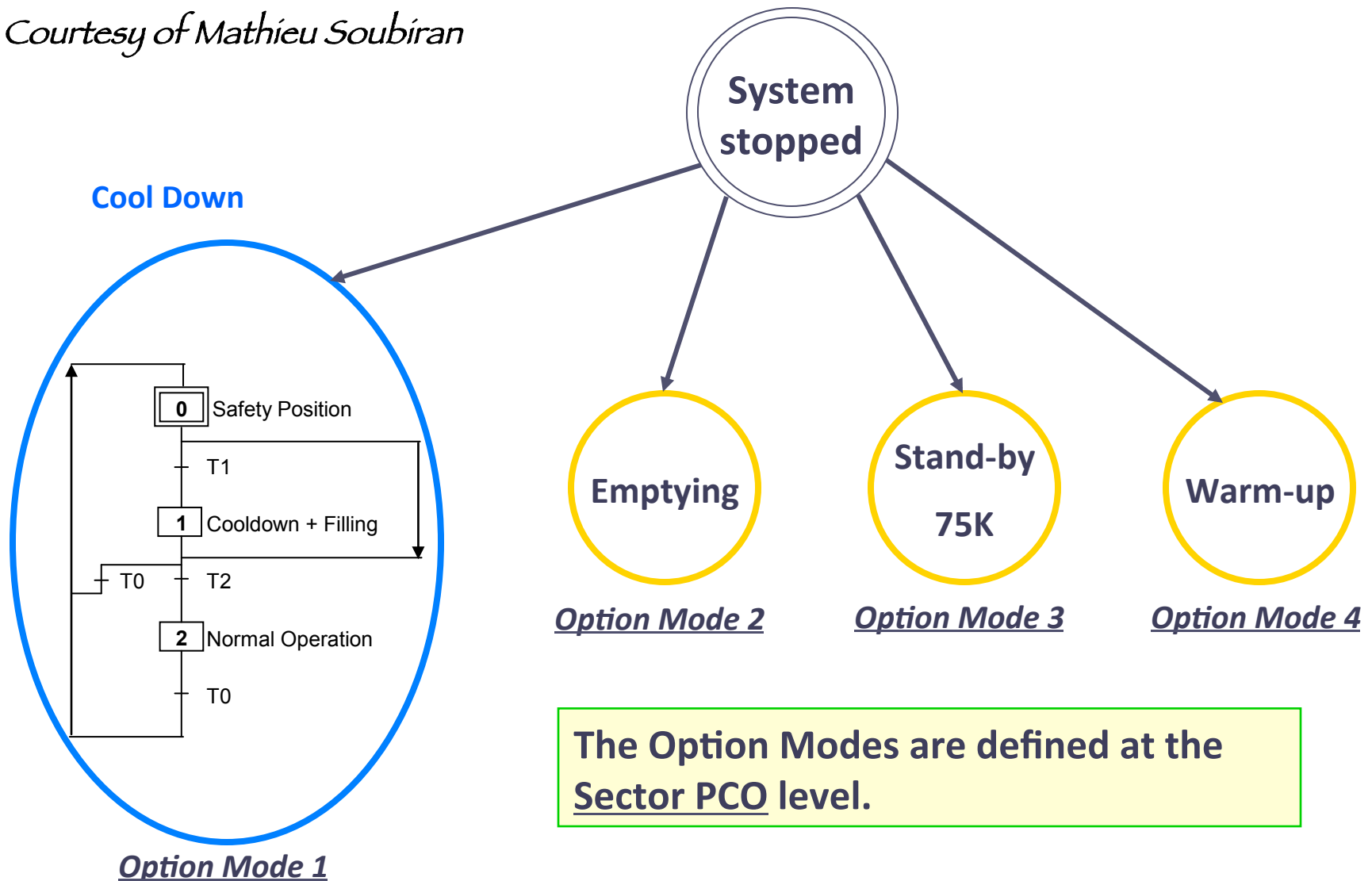


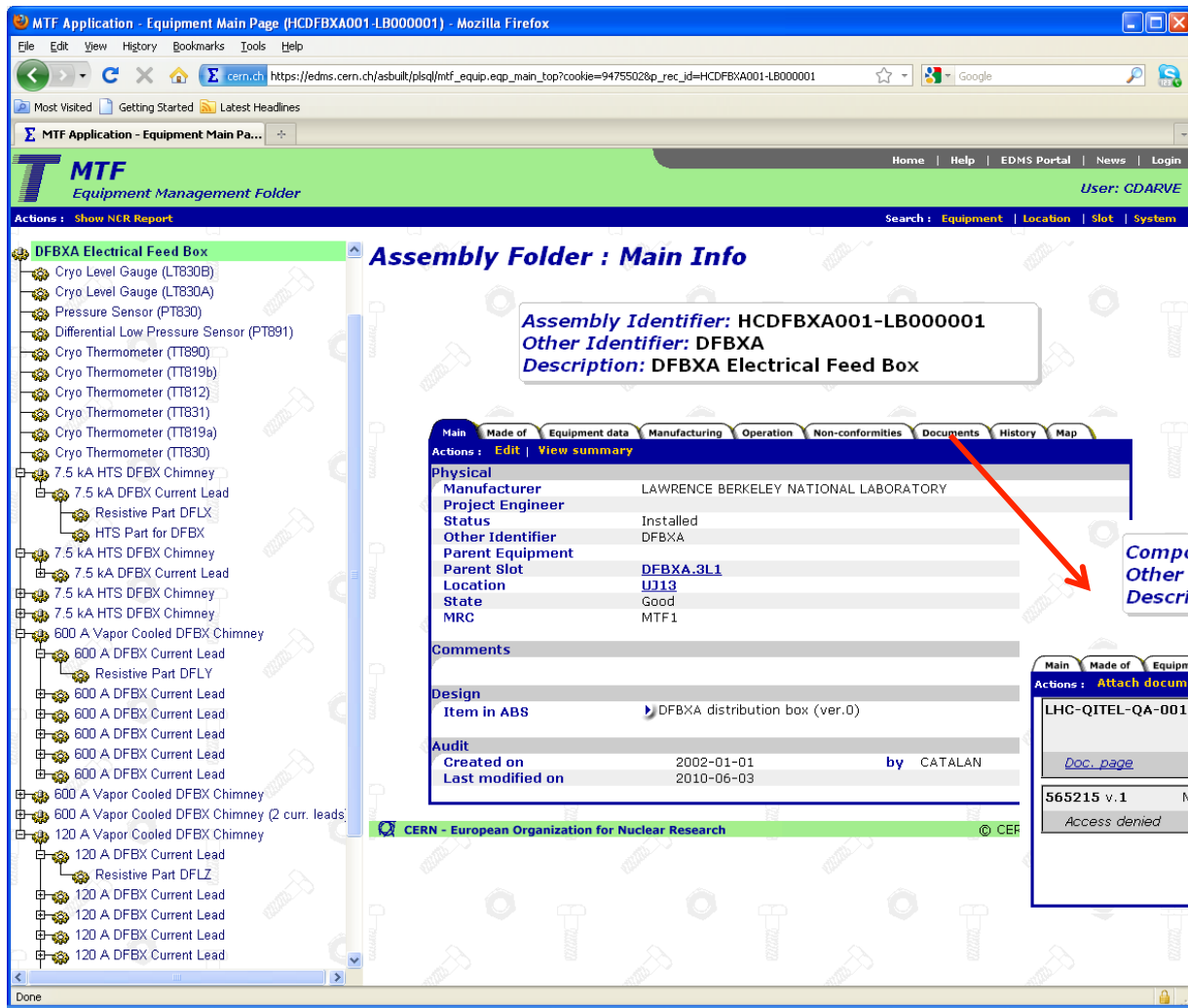
Availability : Process Control Object

Courtesy of Mathieu Soubiran



Courtesy of Mathieu Soubiran





The screenshot shows the MTF Application web interface in Mozilla Firefox. The browser address bar shows the URL: https://edm.cern.ch/asbuilt/plsql/mtf equip_main_top?cookie=9475502&rec_id=HCDFBXA001-LB000001. The page title is "MTF Application - Equipment Main Page (HCDFBXA001-LB000001) - Mozilla Firefox".

The interface displays the "Assembly Folder : Main Info" for the equipment "DFBXA Electrical Feed Box". The "Assembly Identifier" is HCDFBXA001-LB000001 and the "Other Identifier" is DFBXA. The "Description" is DFBXA Electrical Feed Box.

The "Physical" tab is selected, showing the following details:

| | |
|------------------|---------------------------------------|
| Manufacturer | LAWRENCE BERKELEY NATIONAL LABORATORY |
| Project Engineer | |
| Status | Installed |
| Other Identifier | DFBXA |
| Parent Equipment | |
| Parent Slot | DFBXA.3L1 |
| Location | UJ13 |
| State | Good |
| MRC | MTF1 |

The "Design" tab is also visible, showing the "Item in ABS" as "DFBXA distribution box (ver.0)".

The "Audit" section shows the following information:

| | | | |
|------------------|------------|----|---------|
| Created on | 2002-01-01 | by | CATALAN |
| Last modified on | 2010-06-03 | | |

The "Documents" tab is selected, showing a list of documents:

| | | |
|-------------------------------|--|---------|
| LHC-QITEL-QA-0011 v.1 | Certificate of Conformity LBNL - DFB for Inner Triplet 36 Cryogenic Thermometers | In Work |
| Doc. page | LHC-QITEL-QA-0011 doc (162 Kb) | |
| 565215 v.1 | Manufacturing Document for HCQITELCXT-CR015430 | In Work |
| Access denied | | |

A red arrow points from the "Documents" tab in the "Physical" section to the "Component Identifier" box, which contains the following information:

Component Identifier: HCQITELCXT-CR015430
Other Identifier: CX_LS_X17957
Description: Cryo Thermometer (TT831)